



Tektronix MSO44 Series Mixed Signal Oscilloscope User Guide

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Tektronix®



4 Series MSO
MSO44, MSO46, MSO44B and MSO46B
Specifications and Performance Verification

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MSO44 Series Mixed Signal Oscilloscope

Warning: The servicing instructions are for use by qualified personnel only. To avoid personal injury, do not perform any servicing unless you are qualified to do so. Refer to all safety summaries prior to performing service.

Revision B

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For product information, sales, service, and technical support visit tek.com to find contacts in your area. For warranty information visit tek.com/warranty.

Important safety information

This manual contains information and warnings that must be followed by the user for safe operation and to keep the product in a safe condition.

To safely perform service on this product, see the Service safety summary that follows the General safety summary.

General safety summary

Use the product only as specified. Review the following safety precautions to avoid injury and prevent damage to this product or any products connected to it. Carefully read all instructions. Retain these instructions for future reference.

This product shall be used in accordance with local and national codes.

For correct and safe operation of the product, it is essential that you follow generally accepted safety procedures in addition to the safety precautions specified in this manual.

The product is designed to be used by trained personnel only.

Only qualified personnel who are aware of the hazards involved should remove the cover for repair, maintenance, or adjustment.

Before use, always check the product with a known source to be sure it is operating correctly.

This product is not intended for detection of hazardous voltages.

Use personal protective equipment to prevent shock and arc blast injury where hazardous live conductors are exposed.

While using this product, you may need to access other parts of a larger system. Read the safety sections of the other component manuals for warnings and cautions related to operating the system.

When incorporating this equipment into a system, the safety of that system is the responsibility of the assembler.

of the system.

To avoid fire or personal injury

Use proper power cord

Use only the power cord specified for this product and certified for the country of use. Do not use the provided power cord for other products.

Ground the product

This product is grounded through the grounding conductor of the power cord. To avoid electric shock, the grounding conductor must be connected to earth ground. Before making connections to the input or output terminals of the product, ensure that the product is properly grounded. Do not disable the power cord grounding connection.

Power disconnect

The power cord disconnects the product from the power source. See instructions for the location. Do not position the equipment so that it is difficult to operate the power cord; it must remain accessible to the user at all times to allow for quick disconnection if needed.

Connect and disconnect properly

Do not connect or disconnect probes or test leads while they are connected to a voltage source. Use only insulated voltage probes, test leads, and adapters supplied with the product, or indicated by Tektronix to be suitable for the product.

Observe all terminal ratings

To avoid fire or shock hazard, observe all rating and markings on the product. Consult the product manual for further ratings information before making connections to the product.

Do not exceed the Measurement Category (CAT) rating and voltage or current rating of the lowest rated individual component of a product, probe, or accessory. Use caution when using 1:1 test leads because the probe tip voltage is directly transmitted to the product.

Do not apply a potential to any terminal, including the common terminal, that exceeds the maximum rating of that terminal.

Do not float the common terminal above the rated voltage for that terminal.

The measurement terminals on this product are not rated for connection to Category III or IV circuits.

Do not operate without covers

Do not operate this product with covers or panels removed, or with the case open. Hazardous voltage exposure is possible.

Avoid exposed circuitry

Do not touch exposed connections and components when power is present.

Do not operate with suspected failures

If you suspect that there is damage to this product, have it inspected by qualified service personnel.

Disable the product if it is damaged. Do not use the product if it is damaged or operates incorrectly. If in doubt about safety of the product, turn it off and disconnect the power cord. Clearly mark the product to prevent its further operation.

Before use, inspect voltage probes, test leads, and accessories for mechanical damage and replace when damaged. Do not use probes or test leads if they are damaged, if there is exposed metal, or if a wear indicator shows.

Examine the exterior of the product before you use it. Look for cracks or missing pieces.

Use only specified replacement parts.

Do not operate in wet/damp conditions

Be aware that condensation may occur if a unit is moved from a cold to a warm environment.

Do not operate in an explosive atmosphere

Keep product surfaces clean and dry

Remove the input signals before you clean the product.

Provide proper ventilation

Refer to the installation instructions in the manual for details on installing the product so it has proper ventilation.

Slots and openings are provided for ventilation and should never be covered or otherwise obstructed. Do not push objects into any of the openings.

Provide a safe working environment

Always place the product in a location convenient for viewing the display and indicators.

Avoid improper or prolonged use of keyboards, pointers, and button pads. Improper or prolonged keyboard or pointer use may result in serious injury.

Be sure your work area meets applicable ergonomic standards. Consult with an ergonomics professional to avoid stress injuries.

Use care when lifting and carrying the product. This product is provided with a handle or handles for lifting and

carrying.

Use only the Tektronix rackmount hardware specified for this product.

Probes and test leads

Before connecting probes or test leads, connect the power cord from the power connector to a properly grounded power outlet.

Keep fingers behind the protective barrier, protective finger guard, or tactile indicator on the probes. Remove all probes, test leads and accessories that are not in use.


Use only correct Measurement Category (CAT), voltage, temperature, altitude, and amperage rated probes, test leads, and adapters for any measurement.

Beware of high voltages

Understand the voltage ratings for the probe you are using and do not exceed those ratings. Two ratings are important to know and understand:

- The maximum measurement voltage from the probe tip to the probe reference lead.
- The maximum floating voltage from the probe reference lead to earth ground.

These two voltage ratings depend on the probe and your application. Refer to the Specifications section of the manual for more information.

 **WARNING:** To prevent electrical shock, do not exceed the maximum measurement or maximum floating voltage for the oscilloscope input BNC connector, probe tip, or probe reference lead.

Connect and disconnect properly

Connect the probe output to the measurement product before connecting the probe to the circuit under test. Connect the probe reference lead to the circuit under test before connecting the probe input. Disconnect the probe input and the probe reference lead from the circuit under test before disconnecting the probe from the measurement product.

De-energize the circuit under test before connecting or disconnecting the current probe.

Connect the probe reference lead to earth ground only.

Do not connect a current probe to any wire that carries voltages or frequencies above the current probe voltage rating.

Inspect the probe and accessories

Before each use, inspect probe and accessories for damage (cuts, tears, or defects in the probe body, accessories, or cable jacket). Do not use if damaged.

Service safety summary

The Service safety summary section contains additional information required to safely perform service on the product. Only qualified personnel should perform service procedures. Read this Service safety summary and the General safety summary before performing any service procedures.

To avoid electric shock

Do not touch exposed connections.

Do not service alone

Do not perform internal service or adjustments of this product unless another person capable of rendering first aid and resuscitation is present.

Disconnect power

To avoid electric shock, switch off the product power and disconnect the power cord from the mains power before removing any covers or panels, or opening the case for servicing.

Use care when servicing with power on

Dangerous voltages or currents may exist in this product. Disconnect power, remove battery (if applicable), and disconnect test leads before removing protective panels, soldering, or replacing components.


Verify safety after repair

Always recheck ground continuity and mains dielectric strength after performing a repair.

Terms in this manual

These terms may appear in this manual:

 **WARNING:** Warning statements identify conditions or practices that could result in injury or loss of life.


 **CAUTION:** Caution statements identify conditions or practices that could result in damage to this product or other property.

Terms on the product

These terms may appear on the product:

- DANGER indicates an injury hazard immediately accessible as you read the marking.
- WARNING indicates an injury hazard not immediately accessible as you read the marking.
- CAUTION indicates a hazard to property including the product.

Symbols on the product

 When this symbol is marked on the product, be sure to consult the manual to find out the nature of the potential hazards and any actions which have to be taken to avoid them. (This symbol may also be used to refer the user to ratings in the manual.)

The following symbols(s) may appear on the product.



Specifications

This chapter contains specifications for the instrument. All specifications are typical unless noted as guaranteed. Typical specifications are provided for your convenience but are not guaranteed. Specifications that are marked with the ✓ symbol are guaranteed and checked in Performance Verification.

To meet specifications, these conditions must first be met:

- The instrument must have been calibrated in an ambient temperature between 18 °C and 28 °C (64 °F and 82 °F).
 - The instrument must be operating within the environmental limits described in these specifications.
 - The instrument must be powered from a source that meets the specifications.
 - The instrument must have been operating continuously for at least 20 minutes within the specified operating temperature range.
 - You must perform the Signal path compensation procedure after the warmup period. See the Signal path compensation procedure for how to perform signal path compensation. If the ambient temperature changes more than 5 °C (9 °F), repeat the procedure.
 - The measurement system is powered from a TekVPI compatible oscilloscope
- Warranted specifications describe guaranteed performance with tolerance limits or certain type-tested requirements.

Analog channel input and vertical specification

Number of input channels 4 analog channel model: 4 BNC 6 analog channel model: 6 BNC

Input coupling DC, AC

Input resistance selection 1 MΩ or 50 Ω

✓ Input impedance 1 MΩ DC coupled

1 MΩ ±1%

Input capacitance 1 MΩ DC coupled, typical

✓ Input impedance 50 Ω, DC coupled 13 pF ±1.5 pF

MSO44, MSO46: 50 Ω ±1% (VSWR ≤1.5:1, typical)

MSO44B, MSO46B: 50 Ω ±1% (VSWR ≤1.5:1, typical for frequencies <1GHz, ≤2.0:1 for frequencies equal to or above 1GHz)

Maximum input voltage, 1 MΩ 300 V at the BNC

Derate at 20 dB/decade between 4.5 MHz and 45 MHz; derate 14 dB/decade between 45 MHz and 450 RMS MHz. Above 450 MHz, 5.5 V RMS

Maximum peak input voltage at the BNC: ±425 V

Maximum input voltage, 50 Ω 5 V RMS, with peaks ≤ ±20 V (DF ≤6.25%)

Number of Digitized Bits 8 bits at 6.25 GS/s 12 bits at 3.125 GS/s 13 bits at 1.25 GS/s 14 bits at 625 MS/s 15 bits at 250 MS/s 16 bits at 125 MS/s Displayed vertically with 25 digitization levels (DL) for 8-bit and 400 digitization

levels for 12-bit per division, 10.24 divisions dynamic range. DL is the abbreviation for digitization level. A DL is the smallest voltage level change that can be resolved by an 8-bit A-D Converter. This value is also known as an LSB (least significant bit).

Sensitivity range, coarse

1 M Ω 500 μ V/div to 10 V/div in a 1-2-5 sequence

50 Ω 500 μ V/div to 1 V/div in a 1-2-5 sequence

500 μ V/div is a 2X digital zoom of 1 mV/div or a 4x digital zoom of 2 mV/div, depending on the instrument bandwidth configuration

Sensitivity range, fine

1 M Ω Allows continuous adjustment from 500 μ V/div to 10 V/div

50 Ω Allows continuous adjustment from 500 μ V/div to 1 V/div

Sensitivity resolution, fine $\leq 1\%$ of current setting

✓ DC gain accuracy

Step Gain, 50 Ω $\pm 1.0\%$, ($\pm 2.5\%$ at 1 mV/div and 500 μ V/div settings), de-rated at 0.100%/ $^{\circ}\text{C}$ above 30 $^{\circ}\text{C}$

Step Gain, 1 M Ω $\pm 1.0\%$, ($\pm 2.0\%$ at 1 mV/div and 500 μ V/div settings), de-rated at 0.100%/ $^{\circ}\text{C}$ above 30 $^{\circ}\text{C}$

Variable gain $\pm 1.5\%$, derated at 0.100%/ $^{\circ}\text{C}$ above 30 $^{\circ}\text{C}$.

500 μ V/div is a 2X digital zoom of 1 mV/div or a 4x digital zoom of 2 mV/div, depending on the instrument bandwidth configuration. As such, it is guaranteed by testing the non-zoomed setting.

Offset ranges, maximum Input signal cannot exceed maximum input voltage for the 50 Ω input path.

Volts/div setting	Maximum offset range, 50 Ω input
500 μ V/div – 99 mV/div	± 1 V
100 mV/div – 1 V/div	± 10 V

Volts/div setting	Maximum offset range, 1 M Ω input
500 μ V/div – 63 mV/div	± 1 V
64 mV/div – 999 mV/div	± 10 V
1 V/div – 10 V/div	± 100 V

500 μ V/div is a 2X digital zoom of 1 mV/div or a 4x digital zoom of 2 mV/div, depending on the instrument bandwidth configuration. As such, it is guaranteed by testing the non-zoomed setting.

Position range ± 5 divisions

✓ DC Offset accuracy $\pm(0.010 \times |\text{offset} - \text{position}| + \text{DC balance})$

DC Balance is 0.2 div (0.4 div in 500 μ V/div)

DC voltage measurement accuracy, Average acquisition mode

Measurement Type	DC Accuracy (In Volts)
Average of ≥ 16 waveforms	$\pm((\text{DC Gain Accuracy}) * \text{reading} - (\text{offset} - \text{position}) + \text{Offset Accuracy} + 0.1 * \text{V/div setting})$
Delta volts between any two averages of ≥ 16 waveforms acquired with the same oscilloscope setup and ambient conditions	$\pm(\text{DC Gain Accuracy} * \text{reading} + 0.05 \text{ div})$

Bandwidth selections 50 Ω : 20 MHz, 250 MHz, and the full bandwidth value of your model 1 M Ω : 20 MHz, 250 MHz, 350 MHz, 500 MHz 350 MHz models cannot be configured to 500 MHz in 1 M Ω mode

✓ Analog bandwidth 50 Ω DC coupled

1.5 GHz models

Volts/Div Setting	Bandwidth
1 mV/div – 1 V/div	DC – 1.50 GHz
500 μ V/div – 995 μ V/div	DC – 250 MHz

1 GHz models

Volts/Div Setting	Bandwidth
1 mV/div – 1 V/div	DC – 1.00 GHz
500 μ V/div – 995 μ V/div	DC – 250 MHz

500 MHz models

Volts/Div Setting	Bandwidth
1 mV/div – 1 V/div	DC – 500 MHz
500 μ V/div – 995 μ V/div	DC – 250 MHz

350 MHz models

Volts/Div Setting	Bandwidth
1 mV/div – 1 V/div	DC – 350 MHz
500 μ V/div – 995 μ V/div	DC – 250 MHz

200 MHz models

Volts/Div Setting	Bandwidth
1 mV/div – 1 V/div	DC – 200 MHz
500 μ V/div – 995 μ V/div	DC – 200 MHz

All model bandwidths except 350 MHz, 200 MHz

The limits are for ambient temperature of ≤ 30 °C and the bandwidth selection set to FULL. Reduce the upper bandwidth frequency by 1% for each °C above 30 °C.

Volts/Div Setting	Bandwidth
1 mV/div – 10 V/div	DC – 500 MHz
500 μ V/div – 995 μ V/div	DC – 250 MHz

350 MHz models

Volts/Div Setting	Bandwidth
1 mV/div – 10 V/div	DC – 350 MHz
500 μ V/div – 995 μ V/div	DC – 250 MHz

200 MHz models

Volts/Div Setting	Bandwidth
1 mV/div – 10 V/div	DC – 200 MHz
500 μ V/div – 995 μ V/div	DC – 200 MHz

Analog bandwidth with TPP0500, TPP1000 and TPP0250 probes, typical

The limits are for ambient temperature of ≤ 30 °C and the bandwidth selection set to FULL. Reduce the upper bandwidth frequency by 1% for each °C above 30 °C.

Instrument	Volts/Div Setting	Bandwidth
1.5 GHz, 1 GHz	5 mV/div – 100 V/div	DC – 1 GHz (TPP1000 Probe)
500 MHz	5 mV/div – 100 V/div	DC – 500 MHz (TPP0500 Probe)
350 MHz	5 mV/div – 100 V/div	DC – 350 MHz (TPP0500 Probe)
200 MHz	5 mV/div – 100 V/div	DC – 200 MHz (TPP0250 Probe)

Lower frequency limit, AC coupled, typical <10 Hz when AC 1 M Ω coupled. The AC coupled lower frequency limits are reduced by a factor of 10 (<1 Hz) when 10X passive probes are used.

Upper frequency limit, 250 MHz bandwidth limited, typical

Upper frequency limit, 20 MHz bandwidth limited, typical 250 MHz, $\pm 25\%$ 20 MHz, $\pm 25\%$

Calculated rise time, typical

Model	50 Ω	TP1000 Probe	TPP0500 Probe	TPP0250 Probe
	500 μ V-1 V	5 mV-10 V	5 mV-10 V	5 mV-10 V
1.5 GHz	333ps	450ps	900ps	1.8ns
1 GHz	450ps	450ps	900ps	1.8ns
500 MHz	900ps	900ps	900ps	1.8ns
350 MHz	1.3ns	1.3ns	1.3ns	1.8ns
200 MHz	2.3ns	2.3ns	2.3ns	2.3ns

Peak Detect or Envelope mode pulse response, typical Minimum pulse width is >640 ps (6.25 GS/s)

Effective bits (ENOB), typical

Typical effective bits for a 9-division p-p sine-wave input, 50 mV/div, 50- Ω

Sample mode, 50 Ω , 50 mV/div

Bandwidth	Input frequency	ENOB at 6.25 GS/s
1.5 GHz	10 MHz	6.80
1.5 GHz	300 MHz	6.80
1 GHz	10 MHz	7.10
1 GHz	300 MHz	7.10
500 MHz	10 MHz	7.40
500 MHz	150 MHz	7.40
350 MHz	10 MHz	7.60
350 MHz	100 MHz	7.60
250 MHz	10 MHz	7.60
250 MHz	100 MHz	7.60
200 MHz	10 MHz	7.60
200 MHz	100 MHz	7.60
20 MHz	10 MHz	7.70

High Res mode, 50 Ω , 50 mV/div

Bandwidth	Input frequency	ENOB at 6.25 GS/s
1.5 GHz	10 MHz	7.10
1.5 GHz	300 MHz	7.10
1 GHz	10 MHz	7.60
1 GHz	300 MHz	7.60
500 MHz	10 MHz	7.90
500 MHz	150 MHz	7.90
350 MHz	10 MHz	8.20
350 MHz	100 MHz	8.20
250 MHz	10 MHz	8.20
250 MHz	100 MHz	8.20
200 MHz	10 MHz	8.20
200 MHz	100 MHz	8.20
20 MHz	10 MHz	8.90

Random noise, Sample and High Res Acquisition modes, 50 Ω and 1 M Ω , 6.25 Gs/s=

✓ **1.5 GHz models,**

Sample mode (RMS), 50 Ω

V/div	1.5 GHz
1 mV/div	635 μ V
2 mV/div	635 μ V
5 mV/div	817 μ V
10 mV/div	843 μ V
20 mV/div	920 μ V
50 mV/div	1.582 mV
100 mV/div	3.686 mV
1 V/div	23.753 mV

MSO44 and MSO46, Sample mode (RMS), 50 Ω , typical

V/div	1.5 GHz	1 GHz	500 MHz	350 MHz	250/200 MHz	20 MHz
1 mV/div	490 μ V	300 μ V	220 μ V	145 μ V	120 μ V	80 μ V
2 mV/div	490 μ V	350 μ V	220 μ V	150 μ V	130 μ V	80 μ V
5 mV/div	630 μ V	380 μ V	230 μ V	175 μ V	160 μ V	110 μ V
10 mV/div	650 μ V	400 μ V	280 μ V	220 μ V	215 μ V	155 μ V
20 mV/div	710 μ V	510 μ V	410 μ V	340 μ V	340 μ V	260 μ V
50 mV/div	1.220 mV	980 μ V	890 μ V	760 μ V	760 μ V	630 μ V
100 mV/div	2.84 mV	2.23 mV	1.93 mV	1.61 mV	1.61 mV	1.25 mV
1 V/div	18.3 mV	19.0 mV	17.3 mV	15.0 mV	15.0 mV	12.5 mV

MSO44B and MSO46B, Sample mode (RMS), 50 Ω , typical

V/div	1.5 GHz	1 GHz	500 MHz	350 MHz	250/200 MHz	20 MHz
1 mV/div	520 μ V	320 μ V	210 μ V	150 μ V	120 μ V	80 μ V
2 mV/div	520 μ V	350 μ V	220 μ V	150 μ V	120 μ V	80 μ V
5 mV/div	620 μ V	380 μ V	230 μ V	175 μ V	160 μ V	110 μ V
10 mV/div	620 μ V	400 μ V	270 μ V	220 μ V	215 μ V	180 μ V
20 mV/div	720 μ V	510 μ V	410 μ V	360 μ V	370 μ V	320 μ V
50 mV/div	1.30 mV	1.05 mV	930 μ V	880 μ V	900 μ V	700 μ V
100 mV/div	3.00 mV	2.23 mV	1.93 mV	1.74 mV	1.78 mV	1.45 mV
1 V/div	21.0 mV	19.3 mV	18.1 mV	17.5 mV	17.6 mV	14.0 mV

✓ All models except
1.5 GHz, High Res mode (RMS), 50 Ω

V/div	1 GHz	500 MHz	350 MHz	250/200 MHz	20 MHz
1 mV/div	336 μ V	259 μ V	194 μ V	161 μ V	96 μ V
2 mV/div	363 μ V	259 μ V	194 μ V	161 μ V	96 μ V
5 mV/div	394 μ V	304 μ V	239 μ V	174 μ V	96 μ V
10 mV/div	434 μ V	356 μ V	284 μ V	206 μ V	103 μ V
20 mV/div	551 μ V	466 μ V	349 μ V	298 μ V	141 μ V
50 mV/div	1.038 mV	1.038 mV	739 μ V	596 μ V	259 μ V
100 mV/div	2.102 mV	1.596 mV	1.349 mV	1.349 mV	609 μ V
1 V/div	16.874 mV	12.850mV	11.617 mV	11.617 mV	4.906 mV

MSO44 and MSO46, except
1.5 GHz, High Res mode (RMS), 50 Ω , typical

V/div	1 GHz	500 MHz	350 MHz	250/200 MHz	20 MHz
1 mV/div	260 μ V	200 μ V	150 μ V	125 μ V	75 μ V
2 mV/div	280 μ V	200 μ V	150 μ V	125 μ V	75 μ V
5 mV/div	305 μ V	235 μ V	185 μ V	135 μ V	75 μ V
10 mV/div	335 μ V	275 μ V	220 μ V	160 μ V	80 μ V
20 mV/div	425 μ V	360 μ V	270 μ V	230 μ V	110 μ V
50 mV/div	800 μ V	800 μ V	570 μ V	460 μ V	200 μ V
100 mV/div	1.62 mV	1.23 mV	1.04 mV	1.04 mV	480 μ V
1 V/div	13.0 mV	9.90 mV	8.95 mV	8.95 mV	3.78 mV

MSO44B and MSO46B, except 1.5 GHz, High Res mode (RMS), 50 Ω , typical

V/div	1 GHz	500 MHz	350 MHz	250/200 MHz	20 MHz
1 mV/div	280 μ V	210 μ V	150 μ V	125 μ V	75 μ V
2 mV/div	280 μ V	210 μ V	150 μ V	125 μ V	75 μ V
5 mV/div	300 μ V	230 μ V	185 μ V	135 μ V	75 μ V
10 mV/div	330 μ V	260 μ V	220 μ V	160 μ V	80 μ V
20 mV/div	420 μ V	350 μ V	270 μ V	230 μ V	110 μ V
50 mV/div	800 μ V	780 μ V	570 μ V	460 μ V	200 μ V
100 mV/div	1.65 mV	1.29 mV	1.04 mV	1.04 mV	480 μ V
1 V/div	13.0 mV	10.0 mV	8.95 mV	8.95 mV	3.78 mV

MSO44 and MSO46, Sample mode (RMS), 1 M Ω , typical

V/div	500 MHz	350 MHz	250/200 MHz	20 MHz
1 mV/div	210 μ V	140 μ V	120 μ V	78 μ V
2 mV/div	210 μ V	140 μ V	120 μ V	78 μ V
5 mV/div	230 μ V	160 μ V	135 μ V	96 μ V
10 mV/div	270 μ V	200 μ V	190 μ V	135 μ V
20 mV/div	370 μ V	300 μ V	300 μ V	240 μ V
50 mV/div	760 μ V	600 μ V	650 μ V	750 μ V
100 mV/div	1.75 mV	1.350 mV	1.45 mV	1.22 mV
1 V/div	19.00 mV	15.25 mV	15.70 mV	11.20 mV

MSO44B and MSO46B, Sample mode (RMS), 1 M Ω , typical

V/div	500 MHz	350 MHz	250/200 MHz	20 MHz
1 mV/div	220 μ V	150 μ V	120 μ V	75 μ V
2 mV/div	220 μ V	150 μ V	120 μ V	75 μ V
5 mV/div	230 μ V	170 μ V	135 μ V	100 μ V
10 mV/div	270 μ V	210 μ V	200 μ V	170 μ V
20 mV/div	370 μ V	300 μ V	300 μ V	240 μ V
50 mV/div	760 μ V	600 μ V	650 μ V	750 μ V
100 mV/div	1.75 mV	1.350 mV	1.45 mV	1.22 mV
1 V/div	19.00 mV	15.25 mV	15.70 mV	11.20 mV

MSO44 and MSO46, High Res mode (RMS), 1 M Ω , typical

V/div	500 MHz	350 MHz	250/200 MHz	20 MHz
1 mV/div	200 μ V	140 μ V	120 μ V	75 μ V
2 mV/div	200 μ V	140 μ V	120 μ V	75 μ V
5 mV/div	210 μ V	150 μ V	130 μ V	75 μ V
10 mV/div	230 μ V	160 μ V	150 μ V	80 μ V
20 mV/div	280 μ V	200 μ V	200 μ V	100 μ V
50 mV/div	520 μ V	370 μ V	410 μ V	180 μ V
100 mV/div	1.24 mV	880 μ V	930 μ V	460 μ V
1 V/div	14.3 mV	10.20 mV	10.30 mV	5.45 mV

MSO44B and MSO46B, High Res mode (RMS), 1 M Ω , typical

V/div	500 MHz	350 MHz	250/200 MHz	20 MHz
1 mV/div	200 μ V	150 μ V	120 μ V	70 μ V
2 mV/div	210 μ V	150 μ V	120 μ V	70 μ V
5 mV/div	220 μ V	160 μ V	130 μ V	70 μ V
10 mV/div	230 μ V	170 μ V	150 μ V	75 μ V
20 mV/div	300 μ V	230 μ V	220 μ V	100 μ V
50 mV/div	550 μ V	450 μ V	450 μ V	200 μ V
100 mV/div	1.35 mV	1.00 mV	1.03 mV	480 μ V
1 V/div	15.0 mV	11.5 mV	11.5 mV	5.80 mV

✓ All models, High Res mode (RMS), 1 M Ω

V/div	500 MHz	350 MHz	250/200 MHz	20 MHz
1 mV/div	259 μ V	181 μ V	155 μ V	96 μ V
2 mV/div	259 μ V	181 μ V	155 μ V	96 μ V
5 mV/div	271 μ V	194 μ V	168 μ V	96 μ V
10 mV/div	298 μ V	206 μ V	194 μ V	103 μ V
20 mV/div	363 μ V	259 μ V	259 μ V	129 μ V
50 mV/div	674 μ V	479 μ V	531 μ V	233 μ V
100 mV/div	1.609 mV	1.141 mV	1.206 mV	596 μ V
1 V/div	18.561 mV	13.239 mV	13.369 mV	7.074 mV

Delay between analog channels, full bandwidth, typical ≤ 100 ps for any two channels with input impedance set to 50 Ω , DC coupling with equal Volts/div or above 10 mV/div

Deskew range MSO44, MSO46: -125 ns to +125 ns with a resolution of 40 ps

MSO44B, MSO46B: -125 ns to +125 ns with a resolution of 40 ps (for Peak Detect and Envelope acquisition modes). -125 ns to +125 ns with a resolution of 1 ps (for all other acquisition modes).

Crosstalk (channel isolation), typical $\geq 200:1$ up to the rated bandwidth for any two channels having equal Volts/div settings

Total probe power TekVPI+ Compliant probe interfaces: (4 per MSO44, 6 per MSO46) and 1 TekVPI interface for Aux In

MSO46: 80 W maximum (40 W maximum for channels 1-3, 40 W maximum for channels 4-6 and Aux In)

MSO44: 80 W maximum (40 W maximum for channels 1-3, 40 W maximum for channel 4 and Aux In)

Probe power per channel

Voltage	Max Amperage	Voltage Tolerance
5 V	60 mA	$\pm 10\%$
12 V	1.67 A (20 W maximum software limit)	$\pm 10\%$

TekVPI interconnect All analog channel inputs on the front panel conform to the TEKVP1 specification.

Timebase system

Sample rate

Max HW Capability	Number of Channels
6.25 GS/s	1-6

Interpolated waveform rate range 500 GS/sec, 250 GS/sec, 125 GS/sec, 62.5 GS/sec, 25 GS/sec, and 12.5 GS/sec

Record length range

Standard 1 k points to 31.25 M points in single sample increments

Optional 62.5 M points

Seconds/Division range

Model	1 K	10 K	100 K	1 M	10 M	31.25 M	62.5 M
MSO4X Standard 3 1.25 M	200 ps – 64 s	200 ps – 640 s	200 ps – 1000 s				N/A
MSO4X Option 62.5 M	200 ps – 64 s	200 ps – 640 s	200 ps – 1000 s				
MSO4BX Standard 31.25 M	20 ps – 64 s	20 ps – 640 s	400 ps – 1000 s				
MSO4BX Option 62.5 M	20 ps – 64 s	20 ps – 640 s	400 ps – 1000 s				

Maximum triggered acquisition rate, typical Analog or digital channels: single channel [Analog or Digital 8-bit channel] on screen, measurements and math turned off. >20 wfm/sec

FastAcq Update Rate (analog only): >500 K/second with one channel active and >100 K/second with all channels active.

Digital channel: >20/second with one channel (8-bits) active. There is no FastAcq for digital channels, but they do not slow down FastAcq for active analog channels. Aperture uncertainty $\leq 0.450 \text{ fs} + (10$

✓ Timebase accuracy $\pm 2.5 \times 10^{-6} - 11 \times \text{Measurement Duration}$) over any $\geq 1 \text{ ms}$ time interval. RMS , for measurements having duration $\leq 100 \text{ ms}$

Description	Specification
Factory Tolerance	$\pm 5.0 \times 10^{-7}$; at calibration, 25 °C ambient, over any $\geq 1 \text{ ms}$ interval.
Temperature stability, typical	$\pm 5.0 \times 10^{-7}$; tested at operating temperatures.
Crystal aging	$\pm 1.5 \times 10^{-6}$; frequency tolerance change at 25 °C over a period of 1 year.

Delta-time measurement accuracy, nominal

The formulas to calculate the peak-to-peak or rms nominal delta-time measurement accuracy (DTA) for a given instrument setting and input signal is as follows (assumes insignificant signal content above Nyquist frequency):

$$DTA_{pp}(\text{typical}) = 10 \times \sqrt{\left(\frac{N}{SR_1}\right)^2 + \left(\frac{N}{SR_2}\right)^2 + \left(0.450 \text{ ps} + \left(1 \times 10^{-11} \times t_p\right)\right)^2} + TBA \times t_p$$

$$DTA_{RMS} = \sqrt{\left(\frac{N}{SR_1}\right)^2 + \left(\frac{N}{SR_2}\right)^2 + \left(0.450 \text{ ps} + \left(1 \times 10^{-11} \times t_p\right)\right)^2} + TBA \times t_p$$

Where:

N = input-referred guaranteed noise limit (V)

SR 1 = Slew Rate (1 st Edge) around 1 st RMS point in measurement SR 2 = Slew Rate (2nd Edge) around 2nd point in measurement t = delta-time measurement duration (sec)

TBA = timebase accuracy or Reference Frequency Error ± 0.5 ppm p

(Assumes insignificant error due to aliasing or over-drive.)

The term under the square root sign is the stability and is due to TIE (Time Interval Error). The errors due to this term occur throughout a single-shot measurement. The second term is due to both the absolute center-frequency accuracy and the center-frequency stability of the timebase and varies between multiple single-shot measurements over the observation interval (the amount of time from the first single-shot measurement to the final single-shot measurement).

⚠ Note: The formulas assume negligible errors due to measurement interpolation, and apply only when the interpolated sample rate is 25 GS/s or higher.

Trigger system

Trigger bandwidth (edge, pulse, and logic)

1.5 GHz models, Edge = 1.5 GHz

1.5 GHz models, Pulse and Logic = 1 GHz

1 GHz models = 1 GHz

500 MHz models = 500 MHz

350 MHz models = 350 MHz

200 MHz models = 200 MHz

Edge-type trigger sensitivity, DC coupled, typical

Path	Range	Specification
1 M Ω path (all models)	0.5 mV/div to 0.99 mV/div	4.5 div from DC to instrument bandwidth
	≥ 1 mV/div	The greater of 5 mV or 0.7 div
50 Ω path, all models		The greater of 5.6 mV or 0.7 div for frequencies between DC and 500 MHz or the instrument bandwidth (whichever is lower)
		The greater of 7 mV or 0.8 div for frequencies above 500 MHz (if applicable)

Trigger jitter, typical ≤ 7 ps RMS

Edge-type trigger sensitivity, not DC coupled, typical

Trigger Coupling	Typical Sensitivity
NOISE REJ	2.5 times the DC Coupled limits
HF REJ	1.0 times the DC Coupled limits from DC to 50 kHz. Attenuates signals above 50 kHz.
LF REJ	1.5 times the DC Coupled limits for frequencies above 50 kHz. Attenuates signals below 50 kHz.

Logic-type triggering, minimum logic or rearm time, typical t_{rise} is rise time of the instrument. rise

Triggering type	Pulse width	Rearm time	Time skew needed for 100% and no triggering
Logic	$160\text{ ps} + t_{rise}$	$160\text{ ps} + t_{rise}$	$>360\text{ ps} / <150\text{ ps}$
Time qualified logic	$320\text{ ps} + t_{rise}$	$320\text{ ps} + t_{rise}$	$>360\text{ ps} / <150\text{ ps}$

For Logic, time between channels refers to the length of time a logic state derived from more than one channel must exist to be recognized. For Events, the time is the minimum time between a main and delayed event that will be recognized if more than one channel is used.

Minimum clock pulse widths for setup/hold time violation trigger, typical t_{rise} is rise time of the instrument.

Minimum pulse width, clock active	Minimum pulse width, clock inactive
$320\text{ ps} + t_{rise}$	$320\text{ ps} + t_{rise}$

Active pulse width is the width of the clock pulse from its active edge (as defined in the Clock Edge menu item) to its inactive edge. Inactive pulse width is the width of the pulse from its inactive edge to its active edge.#

Setup/hold violation trigger, setup and hold time ranges, typical

Feature	Min	Max
Setup Time	0 ns	20 s
Hold Time	0 ns	20 s
Setup + Hold Time	320 ps	22 s

Input coupling on clock and data channels must be the same.

For Setup Time, positive numbers mean a data transition before the clock.

For Hold Time, positive numbers mean a data transition after the clock edge.

Setup + Hold Time is the algebraic sum of the Setup Time and the Hold Time programmed by the user.

Pulse type trigger, minimum pulse, rearm time, transition time

Pulse class	Minimum pulse width	Minimum rearm time
Runt	$160\text{ ps} + t_{rise}$	$160\text{ ps} + t_{rise}$
Time-Qualified Runt	$160\text{ ps} + t_{rise}$	$160\text{ ps} + t_{rise}$
Width	$160\text{ ps} + t_{rise}$	$160\text{ ps} + t_{rise}$
Slew Rate (minimum transition time)	$160\text{ ps} + t_{rise}$	$160\text{ ps} + t_{rise}$

For trigger class width, pulse width refers to the width of the pulse being measured. Rearm time refers to the time between pulses.

For trigger class runt, pulse width refers to the width of the pulse being measured. Rearm time refers to the time between pulses.

For trigger class slew rate, pulse width refers to the delta time being measured. Rearm time refers to the time it takes the signal to cross the two trigger thresholds again. t_{rise} rise time of the instrument.

Active pulsewidth is the width of the clock pulse from its active edge (as defined in the Clock Edge menu t_{rise} item) to its inactive edge

Inactive pulsewidth is the width of the pulse from its inactive edge to its active edge.

Transition time trigger, delta time range 160 ps to 20 s.

Time range for glitch, pulse width, timeout, time-qualified runt, or time-qualified window triggering 160 ps to 20 s.

Time accuracy for pulse, glitch, timeout, or width triggering

Time Range	Accuracy
320 ps to 500 ns	$\pm(160 \text{ ps} + (\text{Time-Base-Accuracy} * \text{Setting}))$
520 ns to 10 s	$\pm(160 \text{ ps} + (\text{Time-Base-Accuracy} * \text{Setting}))$

B trigger after events, minimum pulse width and maximum event frequency, typical

Minimum pulse width: $160 \text{ ps} + t_{\text{rise}}$

Maximum event frequency: Instrument bandwidth. t_{rise} is rise time of the instrument.

B trigger, minimum time between arm and trigger, typical 320 ps

For trigger after time, this is the time between the end of the time period and the B trigger event.

For trigger after events, this is the time between the last A trigger event and the first B trigger event.

B trigger after time, time range 160 ps to 20 seconds

B trigger after events, event range 1 to 65,471

Trigger level ranges

Source	Range
Any Channel	± 5 divs from center of screen
Aux In Trigger, typical	$\pm 8 \text{ V}$
Line	Fixed at about 50% of line voltage

This specification applies to logic and pulse thresholds.

Trigger holdoff range 0 ns to 20 seconds

Serial Trigger specifications

Optional serial bus interface triggering

Please refer to the Serial Triggering and Analysis Datasheet, located on the tek.com, for information on available serial triggering options and their triggering capabilities.

Digital acquisition system

Digital channel maximum sample rate	6.25 GS/s
Transition detect (digital peak detect)	Displayed data at sample rates less than 6.25 GS/s (decimated data), that contains multiple transitions between sample points will be displayed with a bright white colored edge.
Digital-To-Analog trigger skew	3 ns
Digital to digital skew	3 ns from bit 0 of any TekVPI channel to bit 0 of any TekVPI channel.
Digital skew within a	MSO44, MSO46: <160 ps within any TekVPI channel
Flex Channel	MSO44B, MSO46B: <200 ps within any TekVPI channel

Digital volt meter (DVM)

Measurement types	DC, AC RMS +DC, AC RMS
Voltage resolution	4 digits

✓ Voltage accuracy

DC:	$\pm((1.5\% * \text{reading} - \text{offset} - \text{position}) + (0.5\% * (\text{offset} - \text{position})) + (0.1 * \text{Volts/div}))$ De-rated at 0.100%/°C of reading – offset – position above 30 °C Signal ± 5 divisions from screen center
AC:	MSO44, MSO46: ± 2% (40 Hz to 1 kHz) with no harmonic content outside 40 Hz to 1 kHz range MSO44B, MSO46B: ± 3% (40 Hz to 1 kHz) with no harmonic content outside 40 Hz to 1 kHz range AC, typical: ± 2% (20 Hz to 10 kHz) For AC measurements, the input channel vertical settings must allow the Vpp input signal to cover between 4 and 10 divisions and must be fully visible on the screen

Trigger frequency counter

✓ Accuracy	$\pm(1 \text{ count} + \text{time base accuracy} * \text{input frequency})$ The signal must be at least 8 mV pp or 2 div, whichever is greater.
✓ Maximum input frequency	10 Hz to maximum bandwidth of the analog channel MSO44, MSO46: The signal must be at least 8 mV or 2 div, whichever is greater. MSO44B, MSO46B: The signal must be at least 8 mV pp or 3 div, whichever is greater.
Resolution	8-digits

Arbitrary Function Generator system

Function types Arbitrary, sine, square, pulse, ramp, triangle, DC level, Gaussian, Lorentz, exponential rise/fall, sin(x)/x, random noise, Haversine, Cardiac
Amplitude range Values are peak-to-peak voltages

Waveform	50 Ω	1 M Ω
Arbitrary	10 mV to 2.5 V	20 mV to 5 V
Sine	10 mV to 2.5 V	20 mV to 5 V
Square	10 mV to 2.5 V	20 mV to 5 V
Pulse	10 mV to 2.5 V	20 mV to 5 V
Ramp	10 mV to 2.5 V	20 mV to 5 V
Triangle	10 mV to 2.5 V	20 mV to 5 V
Gaussian	10 mV to 1.25 V	20 mV to 2.5 V
Lorentz	10 mV to 1.2 V	20 mV to 2.4 V
Exponential Rise	10 mV to 1.25 V	20 mV to 2.5 V
Exponential Fall	10 mV to 1.25 V	20 mV to 2.5 V
Sine(x)/x	10 mV to 1.5 V	20 mV to 3.0 V
Random Noise	10 mV to 2.5 V	20 mV to 5 V
Haversine	10 mV to 1.25 V	20 mV to 2.5 V
Cardiac	10 mV to 2.5 V	20 mV to 5 V

Maximum sample rate 250 MS/s

Arbitrary function record length 128 K Samples

Sine waveform

Frequency range 0.1 Hz to 50 MHz

Frequency setting resolution 0.1 Hz

Amplitude flatness, typical MSO44, MSO46: ± 0.5 dB at 1 kHz

MSO44B, MSO46B: ± 1.0 dB at 1 kHz

± 1.5 dB at 1 kHz for < 20 mV amplitudes

Total harmonic distortion, pp typical

MSO44, MSO46: 1% for amplitude ≥ 200 mV into 50 Ω load

MSO44B, MSO46B: 1.5% for amplitude ≥ 200 mV pp into 50 Ω load

MSO44, MSO46: 2.5% for amplitude > 50 mV AND < 200 mV pp into 50 Ω load

MSO44B, MSO46B: 3.5% for amplitude > 50 mV AND < 200 mV pp into 50 Ω load

This is for Sine wave only.

Spurious free dynamic range, typical

MSO44, MSO46: 40 dB (V pp ≥ 0.1 V); 30 dB (V ≥ 0.02 V), 50 Ω load MSO44B, MSO46B: 35 dB (V pp ≥ 0.2 V), 50 Ω load

Square and pulse waveform

Frequency range	0.1 Hz to 25 MHz
Frequency setting resolution	0.1 Hz
Duty cycle range	10% – 90% or 10 ns minimum pulse, whichever is larger Minimum pulse time applies to both on and off time, so maximum duty cycle will reduce at higher frequencies to maintain 10 ns off time
Duty cycle resolution	0.10%
Minimum pulse width, typical	10 ns. This is the minimum time for either on or off duration.
Rise/Fall time, typical	MSO44, MSO46: 5.5 ns, 10% – 90% MSO44B, MSO46B: 6 ns, 10% – 90%
Pulse width resolution	100 ps
Overshoot, typical	MSO44, MSO46: < 4 % for signal steps greater than 100 mV MSO44B, MSO46B: < 6% for signal steps greater than 100 mV pp pp This applies to overshoot of the positive-going transition (+overshoot) and of the negative-going (-overshoot) transition
Asymmetry, typical	±1% ±5 ns, at 50% duty cycle
Jitter, typical	< 60 ps TIE RMS , ≥ 100 mV pp amplitude, 40%-60% duty cycle
Cardiac maximum frequency	MSO44, MSO46: 1 MHz MSO44B, MSO46B: 500 kHz

Ramp and triangle waveform

Frequency range	0.1 Hz to 500 kHz
Frequency setting resolution	0.1 Hz
Variable symmetry	0% – 100%
Symmetry resolution	0.10%
DC level range	±2.5 V into Hi-Z ±1.25 V into 50 Ω

Gaussian pulse, Haversine, and Lorentz pulse

Maximum frequency	5 MHz
Exponential rise fall maximum frequency Sin(x)/x	5 MHz
Maximum frequency	2 MHz
Random noise amplitude range	20 mV pp to 5 V into Hi-Z 10 mV pp pp to 2.5 V into 50 Ω For both isolated noise signal and additive noise signal.
✓ Sine, ramp, square and pulse frequency accuracy	1.3×10^{-4} (frequency ≤ 10 kHz) 5.0×10^{-5} (frequency > 10 kHz)
Signal amplitude resolution	1 mV (Hi-Z) 500 μ V (50 Ω)
✓ Signal amplitude accuracy	$\pm [(1.5\% \text{ of peak-to-peak amplitude setting}) + (1.5\% \text{ of absolute DC offset setting}) + 1 \text{ mV}]$ (frequency = 1 kHz)
DC offset range	± 2.5 V into Hi-Z ± 1.25 V into 50 Ω
DC offset resolution	1 mV (Hi-Z) 500 μ V (50 Ω)
✓ DC offset accuracy	$\pm [(1.5\% \text{ of absolute offset voltage setting}) + 1 \text{ mV}]$ Add 3 mV of uncertainty per 10 $^{\circ}$ C change from 25 $^{\circ}$ C ambient. Refer DC Offset Accuracy test record on page 42

Display system

Display type	MSO44, MSO46: Display area – 11.38 inches (289 mm) (H) x 6.51 inches (165 mm) (V), 13.3 inches (338 mm) diagonal, 6-bit RGB color, TFT liquid crystal display (LCD) with capacitive touch MSO44B, MSO46B: Display area – 11.57 inches (293.76 mm) (H) x 6.5 inches (165.24 mm) (V), 13.3 inches (338 mm) diagonal, 6-bit RGB color, optically-bonded liquid crystal display (LCD) with capacitive touch
Resolution	1,920 horizontal \times 1,080 vertical pixels
Luminance, typical	MSO44, MSO46: 400 cd/m ² , (Minimum: 320 cd/m ²) MSO44B, MSO46B: 270 cd/m ² Display luminance is specified for a new display set at full brightness.

Processor system

Host processor

MSO44, MSO46: Texas Instruments AM5728

MSO44B, MSO46B: Intel x6413E at 1.5 GHz (HFM) / 3.0 GHz (Turbo). Elkhart Lake 4-Core.

Operating system Closed Linux

Input/Output port specifications

Ethernet interface An 8-pin RJ-45 connector that supports 10/100/1000 Mb/s Video signal output A 29-pin HDMI connector

MSO44, MSO46: Recommended resolution: 1920 x 1080 @ 60 Hz. Video out may not be hot pluggable.

HDMI cable may need to be attached before power up for dual display functions to work depending upon the instrument firmware revision

MSO44B, MSO46B: Supported resolution: 1920 x 1080 @ 60 Hz only. Hot plug support.

USB interface (Host, Device ports)

Front panel USB Host ports: Three USB 2.0 Hi-Speed ports

MSO44, MSO46: Rear panel USB Host ports: Two USB 2.0 Hi-Speed ports
 MSO44B, MSO46B: Rear panel USB Host ports: Two USB 3.1 SuperSpeed ports
 Rear panel USB Device port: One USB 2.0 Hi-Speed Device port providing USBTMC support

Probe compensator signal output voltage and frequency, typical

Output voltage amplitude: 2.5 V $\pm 2\%$ (nominally 0-2.5V)

Output frequency: 1 kHz $\pm 25\%$

Output source impedance nominally 1k Ω

Auxiliary output, AUX OUT, Trigger Out, Event, or Reference Clock Out

Selectable output Acquisition Trigger Out

Reference Clock Out

AFG Trigger Out

Acquisition Trigger Out User selectable transition from HIGH to LOW, or LOW to HIGH, indicates the trigger occurred. The signal returns to its previous state after approximately 100 ns

Acquisition trigger jitter 380 ps (peak-to-peak)

Reference Clock Out Reference clock output tracks the acquisition system and can be referenced from either the internal clock reference or the external clock reference

AFG Trigger Out The output frequency is dependent on the frequency of the AFG signal as shown in the following table:

AFG signal frequency	AFT trigger frequency
≤ 4.9 MHz	Signal frequency
> 4.9 MHz to 14.7 MHz	Signal frequency / 3
> 14.7 MHz to 24.5 MHz	Signal frequency / 5
> 24.5 MHz to 34.3 MHz	Signal frequency / 7
> 34.3 MHz to 44.1 MHz	Signal frequency / 9
> 44.1 MHz to 50 MHz	Signal frequency / 11

AUX OUT Output Voltage

Characteristic	Limits
Vout (HI)	≥ 2.5 V open circuit; ≥ 1.0 V into a 50 Ω load to ground
Vout (LO)	≤ 0.7 V into a load of ≤ 4 mA; ≤ 0.25 V into a 50 Ω load to ground

External reference input

Nominal input frequency 10 MHz

Frequency Variation Tolerance 9.99996 MHz to 10.00004 MHz ($\pm 4.0 \times 10^{-6}$)

Sensitivity, typical V in 1.5 V using a 50 Ω termination

Maximum input signal 7 V pp p-p -6) Impedance MSO44, MSO46: 1.2 K Ohms $\pm 20\%$ in parallel with 18 pf ± 5 pf at 10 MHz MSO44B, MSO46B: 800 Ohms $\pm 20\%$ with 18 pf $\pm 20\%$ to ground at 10 MHz

Data storage specifications

Nonvolatile memory retention time, typical

No time limit for front panel settings, saved waveforms, setups, product licensing, and calibration constants.

Real-time clock A programmable clock providing time in years, months, days, hours, minutes, and seconds.

MSO44 and MSO46 Nonvolatile memory capacity

32 GB Primary MMC Stores the operating system, application software and factory data. No user data

32 GB Secondary MMC Stores saved setups and waveforms, Ethernet settings, log files, user data and user settings

2 Kbit EEPROM Memory on the main board that stores the instrument serial number, instrument start up count, total uptime factory data, security option passwords, and user-settable security option passwords

1 Kbit EEPROM Memory on the main board that stores power management controller factory data

1 KB Flash Memory Memory on the main board that stores the SODIMM memory configuration data (SPD). Two to four pieces depending on model

32 KB Flash Memory Memory on the main board that stores microcontroller firmware. Two pieces

64 KB Flash Memory Memory on the main board that stores microcontroller firmware. Two pieces

MSO44B and MSO46B Nonvolatile memory capacity

eMMC 64G Stores host instrument Linux operating system, application software, and user data including waveforms and measurement results, and instrument settings

Stores user data and user settings Written through the user interface (UI), application software operations, factory operations and programmatic command Located on the Processor Board User accessible To clear, remove and dispose of processor board

To sanitize, remove and dispose of processor board NOR Flash 32 MB Stores host processor bootloader No user data

Access method is indirect Written by factory operations Located on the Processor Board Not user accessible

Clearing or sanitizing: Not applicable, does not contain user data or settings 2 Kbit EEPROM Stores factory data, maintenance data No user data Access method is indirect Written by factory operations Located on the Main Board User accessible Clearing or sanitizing: Not applicable, does not contain user data or settings

1 Kbit EEPROM Stores power management controller factory data, maintenance data No user data Access method is indirect Written by application software operations Located on the Acquisition Board Not user accessible Clearing or sanitizing: Not applicable, does not contain user data or settings

1 Kbit EEPROM Stores the host processor memory configuration data (SPD) No user data Access method is indirect Written by factory operations Located on the Processor Board Not user accessible Clearing or sanitizing: Not applicable, does not contain user data or settings

1 KB Flash Memory Two to four pieces depending on model Stores the SODIMM memory configuration data (SPD) No user data Access method is indirect Written by factory operations Located on the Acquisition Board Not user accessible

Clearing or sanitizing: Not applicable, does not contain user data or settings 32 KB Flash Memory Stores power management micro-controller firmware No user data Access method is indirect Written by application software operations Internal to the MC9S08 micro-controller on the Main Board Not user accessible Clearing or sanitizing: Not applicable, does not contain user data or settings

32 KB FRAM Memory Stores host processor power sequencer micro-controller firmware No user data Access method is indirect Written by application software operations Internal to the MSP430 micro-controller on the Processor Board Not user accessible Clearing or sanitizing: Not applicable, does not contain user data or settings

64 KB Flash Memory Stores analog front end micro-controller firmware No user data

Access method is indirect

Written by application software operations

Internal to the KL14 micro-controller on the Acquisition Board Not user accessible

Clearing or sanitizing: Not applicable, does not contain user data or settings

256 KB Flash Memory Stores front panel micro-controller firmware No user data

Access method is indirect

Written by application software operations

Internal to the TIVA TM4C micro-controller on the Acquisition Board Not user accessible

Clearing or sanitizing: Not applicable, does not contain user data or settings

64 MB Flash Memory Stores the FPGA configuration

No user data

Access method is indirect

Written by application software operations

Located on the Acquisition Board

Not user accessible

Clearing or sanitizing: Not applicable, does not contain user data or settings

64 MB Flash Memory Stores backup copy of the FPGA configuration

No user data

Access method is indirect

Written by application software operations

Located on the Acquisition Board

Not user accessible Clearing or sanitizing: Not applicable, does not contain user data or settings

Power supply system

Power

Power consumption	400 Watts maximum
Source voltage	100 – 240 V $\pm 10\%$ (50 Hz to 60 Hz)
Source frequency	50 Hz to 60 Hz $\pm 10\%$, at 100 – 240 V $\pm 10\%$
Fuse Rating	12.5 A, 250 Vac

Safety characteristics

Safety certification US NRTL Listed – UL61010-1 and UL61010-2-030
 Canadian Certification – CAN/CSA-C22.2 No. 61010.1 and CAN/CSA-C22.2 No 61010.2.030
 EU Compliance – Low Voltage Directive 2014-35-EU and EN61010-1.
 International Compliance – IEC 61010-1 and IEC61010-2-030
 Pollution degree Pollution degree 2, indoor, dry location use only
 Electrical specification Measurement CAT II (300V)

Environmental specifications

Temperature

Operating +0 °C to +50 °C (32 °F to 122 °F)
 Non-operating MSO44, MSO46: -30 °C to +70 °C (-22 °F to 158 °F)
 MSO44B, MSO46B: -20 °C to +60 °C (-4 °F to 140 °F)

Humidity

Operating 5% to 90% relative humidity (% RH) at up to +40 °C
 5% to 50% RH above +40 °C up to +50 °C, noncondensing, and as limited by a maximum wet-bulb temperature of +39 °C
 Non-operating 5% to 90% relative humidity (% RH) at up to +40 °C
 5% to 50% RH above +40 °C up to +50 °C, noncondensing, and as limited by a maximum wet-bulb temperature of +39 °C

Altitude

Operating Up to 3,000 meters (9,843 feet)
 Non-operating Up to 12,000 meters (39,370 feet)
 Operating random vibration MSO44B, MSO46B: 0.31 GRMS, 5-500 Hz, 10 minutes per axis, 3 axes (30 minutes total)
 Operating mechanical shock MSO44B, MSO46B: Half-sine mechanical shocks, 40 g peak amplitude, 11 msec duration, 3 drops in each direction of each axis (18 total)

Mechanical specifications

Dimensions

Height 11.299 in (286.99 mm) with feet folded in, handle to back 13.8 in (351 mm) with feet folded in, handle up
 Width 15.9 in (405 mm) from handle hub to handle hub
 Depth 6.1 in (155 mm) from back of feet to front of knobs, handle up 10.4 in (265 mm) feet folded in, handle to the back
 Weight MSO44, MSO46: < 16.8 lbs (7.6 kg)
 MSO44B: < 16.55 lbs (7.5 kg)
 MSO46B: < 16 lbs (7.3 kg)
 Cooling The clearance requirement for adequate cooling is 2.0 in (50.8 mm) on the right side of the instrument (when viewed from the front) and on the rear of the instrument
 Rackmount Unit fits into rackmount configuration (7U)
 MSO44B and MSO46B Audible noise
 Audible noise (fan noise) produced by the instrument at ambient temperature (=28°C): = 47 dB
 Kensington lock Instrument includes a Kensington lock

Performance verification procedures

This chapter contains performance verification procedures for the specifications marked with the ✓ symbol. The following equipment, or a suitable equivalent, is required to complete these procedures. The performance verification procedures verify the performance of your instrument. They do not adjust your instrument. If your instrument fails any of the performance verification tests, repeat the failing test, verifying that the test equipment

and settings are correct. If the instrument continues to fail a test, contact Tektronix Customer Support for assistance.

These procedures cover all 4 Series MSO instruments. Completion of the performance verification procedure does not update the instrument time and date.

Print the test records on the following pages and use them to record the performance test results for your oscilloscope. Disregard checks and test records that do not apply to the specific model you are testing.

The following table lists the required equipment. You might need additional cables and adapters, depending on the actual test equipment you use.

Required equipment	Minimum requirements	Examples
DC voltage source	3 mV to 4 V, $\pm 0.1\%$ accuracy	Fluke 9500B Oscilloscope Calibrator with a 9530 Output Module
Leveled sine wave generator	50 kHz to 2 GHz, $\pm 4\%$ amplitude accuracy	
Time mark generator	80 ms period, $\pm 1.0 \times 10^{-6}$ accuracy, rise time < 50 ns	
Logic probe	Low capacitance digital probe, 8 channels.	TLP058 probe
BNC-to-0.1 inch pin adapter to connect the logic probe to the signal source.	BNC-to-0.1 inch pin adapter; female BNC to 2×16 .01 inch pin headers.	Tektronix adapter part number 878-1429-00; to connect the Fluke 9500 B to the TLP058 probe.
Digital multimeter (DMM)	0.1% accuracy or better	Tektronix DMM4020
One 50 Ω terminator	Impedance 50 Ω ; connectors: female BNC input, male BNC output	Tektronix part number 011-0049-02
One 50 Ω BNC cable	Male-to-male connectors	Tektronix part number 012-0057-01
Optical mouse	USB, PS2	Tektronix part number 119-7054-00
RF vector signal generator	Maximum bandwidth of instrument	Tektronix TSG4100A

Test record

Instrument information, self test record

Model	Serial #	Procedure performed by	Date

Test	Passed	Failed
Self Test		

Input Impedance test record

Input Impedance				
Performance checks	Vertical scale	Low limit	Test result	High limit
All models				
Channel 1 Input Impedance, 1 M Ω	100 mV/div	990 k Ω		1.01 M Ω
Channel 1 Input Impedance, 50 Ω	10 mV/div	49.5 Ω		50.5 Ω
	100 mV/div	49.5 Ω		50.5 Ω
Channel 2 Input Impedance, 1 M Ω	100 mV/div	990 k Ω		1.01 M Ω
Channel 2 Input Impedance, 50 Ω	10 mV/div	49.5 Ω		50.5 Ω
	100 mV/div	49.5 Ω		50.5 Ω
Channel 3 Input Impedance, 1 M Ω	100 mV/div	990 k Ω		1.01 M Ω
Channel 3 Input Impedance, 50 Ω	10 mV/div	49.5 Ω		50.5 Ω
	100 mV/div	49.5 Ω		50.5 Ω
Channel 4 Input Impedance, 1 M Ω	100 mV/div	990 k Ω		1.01 M Ω
Channel 4, Input Impedance, 50 Ω	10 mV/div	49.5 Ω		50.5 Ω
	100 mV/div	49.5 Ω		50.5 Ω

Input Impedance				
Performance checks	Vertical scale	Low limit	Test result	High limit
6 Channel Models				
Channel 5 Input Impedance, 1 M Ω	100 mV/div	990 k Ω		1.01 M Ω
Channel 5 Input Impedance, 50 Ω	10 mV/div	49.5 Ω		50.5 Ω
	100 mV/div	49.5 Ω		50.5 Ω
Channel 6 Input Impedance, 1 M Ω	100 mV/div	990 k Ω		1.01 M Ω
Channel 6 Input Impedance, 50 Ω	10 mV/div	49.5 Ω		50.5 Ω
	100 mV/div	49.5 Ω		50.5 Ω

DC Gain Accuracy test record

DC Gain Accuracy					
Performance checks	Bandwidth	Vertical scale	Low limit	Test result	High limit
All models					
Channel 1 DC Gain Accuracy, 0 V offset, 0 V vertical position, 500	20 MHz	1 mV/div	-2.5%		2.5%
		2 mV/div	-1%		1%
		5 mV/div	-1%		1%
		10 mV/div	-1%		1%
		20 mV/div	-1%		1%
		50 mV/div	-1%		1%
		100 mV/div	-1%		1%
		200 mV/div	-1%		1%
		500 mV/div	-1%		1%
		1 V/div	-1%		1%
	250 MHz	20 mV/div	-1%		1%
	FULL	20 mV/div	-1%		1%
Channel 1 DC Gain Accuracy, 0 V offset, 0 V vertical position, 1 MO	20 MHz	1 mV/div	-2%		2%
		2 mV/div	-1%		1%
		5 mV/div	-1%		1%
		10 mV/div	-1%		1%
		20 mV/div	-1%		1%
		50 mV/div	-1%		1%
		100 mV/div	-1%		1%
		200 mV/div	-1%		1%
		500 mV/div	-1%		1%
		1 V/div	-1%		1%
	250 MHz	20 mV/div	-1%		1%
	FULL	20 mV/div	-1%		1%

DC Gain Accuracy					
Performance checks	Bandwidth	Vertical scale	Low limit	Test result	High limit
All models					
Channel 2 DC Gain Accuracy, 0 V offset, 0 V vertical position, 500	20 MHz	1 mV/div	-2.5%		2.5%
		2 mV/div	-1%		1%
		5 mV/div	-1%		1%
		10 mV/div	-1%		1%
		20 mV/div	-1%		1%
		50 mV/div	-1%		1%
		100 mV/div	-1%		1%
		200 mV/div	-1%		1%
		500 mV/div	-1%		1%
		1 V/div	-1%		1%
	250 MHz	20 mV/div	-1%		1%
	FULL	20 mV/div	-1%		1%
Channel 2 DC Gain Accuracy, 0 V offset, 0 V vertical position, 1 MO	20 MHz	1 mV/div	-2%		2%
		2 mV/div	-1%		1%
		5 mV/div	-1%		1%
		10 mV/div	-1%		1%
		20 mV/div	-1%		1%
		50 mV/div	-1%		1%
		100 mV/div	-1%		1%
		200 mV/div	-1%		1%
		500 mV/div	-1%		1%
		1 V/div	-1%		1%
	250 MHz	20 mV/div	-1%		1%
	FULL	20 mV/div	-1%		1%

DC Gain Accuracy

Performance checks	Bandwidth	Vertical scale	Low limit	Test result	High limit
All models					
Channel 3 DC Gain	20 MHz	1 mV/div	_as		1%
		2 mV/div	-1%		1%
		5 mV/div	-1%		1%
		10 mV/div	-1%		1%
		20 mV/div	-1%		1%
		50 mV/div	-1%		1%
		100 mV/div	-1%		1%
		200 mV/div	-1%		1%
		500 mV/div	-1%		1%
		1 V/div	-1%		1%
	250 MHz	20 mV/div	-1%		1%
	FULL	20 mV/div	-1%		1%
Channel 3 DC Gain	20 MHz	1 mV/div	-2%		2%
		2 mV/div	-1%		1%
		5 mV/div	-1%		1%
		10 mV/div	-1%		1%
		20 mV/div	-1%		1%
		50 mV/div	-1%		1%
		100 mV/div	-1%		1%
		200 mV/div	-1%		1%
		500 mV/div	-1%		1%
		1 V/div	-1%		1%
	250 MHz	20 mV/div	-1%		1%
	FULL	20 mV/div	-1%		1%

DC Gain Accuracy					
Performance checks	Bandwidth	Vertical scale	Low limit	Test result	High limit
All models					
Channel 4 DC Gain Accuracy, 0 V offset, 0 V vertical position, 500	20 MHz	1 mV/div	-2.5%		2.5%
		2 mV/div	-1%		1%
		5 mV/div	-1%		1%
		10 mV/div	-1%		1%
		20 mV/div	-1%		1%
		50 mV/div	-1%		1%
		100 mV/div	-1%		1%
		200 mV/div	-1%		1%
		500 mV/div	-1%		1%
		1 V/div	-1%		1%
	250 MHz	20 mV/div	-1%		1%
	FULL	20 mV/div	-1%		1%
Channel 4 DC Gain Accuracy, 0 V offset, 0 V vertical position, 1 MO	20 MHz	1 mV/div	-2%		2%
		2 mV/div	-1%		1%
		5 mV/div	-1%		1%
		10 mV/div	-1%		1%
		20 mV/div	-1%		1%
		50 mV/div	-1%		1%
		100 mV/div	-1%		1%
		200 mV/div	-1%		1%
		500 mV/div	-1%		1%
		1 V/div	-1%		1%
	250 MHz	20 mV/div	-1%		1%
	FULL	20 mV/div	-1%		1%

DC Gain Accuracy					
Performance checks	Bandwidth	Vertical scale	Low limit	Test result	High limit
6 channel model					
Channel 5 DC Gain Accuracy, 0 V offset, 0 V vertical position , 50 0	20 MHz	1 mV/div	-2.5%		2.5%
		2 mV/div	-1%		1%
		5 mV/div	-1%		1%
		10 mV/div	-1%		1%
		20 mV/div	-1%		1%
		50 mV/div	-1%		1%
		100 mV/div	-1%		1%
		200 mV/div	-1%		1%
		500 mV/div	-1%		1%
		1 V/div	-1%		1%
	250 MHz	20 mV/div	-1%		1%
	FULL	20 mV/div	-1%		1%
Channel 5 DC Gain Accuracy, 0 V offset, 0 V vertical position , 1 MO	20 MHz	1 mV/div	-2%		2%
		2 mV/div	-1%		1%
		5 mV/div	-1%		1%
		10 mV/div	-1%		1%
		20 mV/div	-1%		1%
		50 mV/div	-1%		1%
		100 mV/div	-1%		1%
		200 mV/div	-1%		1%
		500 mV/div	-1%		1%
		1 V/div	-1%		1%
	250 MHz	20 mV/div	-1%		1%
	FULL	20 mV/div	-1%		1%

DC Gain Accuracy					
Performance checks	Bandwidth	Vertical scale	Low limit	Test result	High limit
6 channel model					
Channel 6 DC Gain Accuracy, 0 V offset, 0 V vertical position, 50 Ω	20 MHz	1 mV/div	-2.5%		2.5%
		2 mV/div	-1%		1%
		5 mV/div	-1%		1%
		10 mV/div	-1%		1%
		20 mV/div	-1%		1%
		50 mV/div	-1%		1%
		100 mV/div	-1%		1%
		200 mV/div	-1%		1%
		500 mV/div	-1%		1%
		1 V/div	-1%		1%
	250 MHz	20 mV/div	-1%		1%
	FULL	20 mV/div	-1%		1%
Channel 6 DC Gain Accuracy, 0 V offset, 0 V vertical position, 1 M Ω	20 MHz	1 mV/div	-2%		2%
		2 mV/div	-1%		1%
		5 mV/div	-1%		1%
		10 mV/div	-1%		1%
		20 mV/div	-1%		1%
		50 mV/div	-1%		1%
		100 mV/div	-1%		1%
		200 mV/div	-1%		1%
		500 mV/div	-1%		1%
		1 V/div	-1%		1%
	250 MHz	20 mV/div	-1%		1%
	FULL	20 mV/div	-1%		1%

DC Offset Accuracy test record

Use the vertical offset value for both the calibrator output and the oscilloscope offset setting.

Offset Accuracy					
Performance checks	Vertical scale	Vertical offset	Low limit	Test result	High limit

All models					
Channel 1 DC Offset Accuracy, 20 MHz BW, 50 Ω	1 mV/div	900 mV	890.8 mV		909.2 mV
	1 mV/div	-900 mV	-909.2 mV		-890.8 mV
	100 mV/div	5.0 V	4.93 V		5.07 V
	100 mV/div	-5.0 V	-5.07 V		-4.93 V
Channel 1 DC Offset Accuracy, 20 MHz BW, 1 M Ω	1 mV/div	900 mV	890.8 mV		-909.2 mV
	1 mV/div	-900 mV	-909.2 mV		-890.8 mV
	100 mV/div	9.0 V	8.89 V		9.11 V
	100 mV/div	-9.0 V	-9.11 V		-8.89 V
	500 mV/div	9.0 V	8.81 V		9.19 V
	500 mV/div	-9.0 V	-9.19 V		-8.81 V
	1.01 mV/div	99.5 V	98.303 V		100.697 V
	1.01 mV/div	-99.5 V	-100.697 V		-98.303 V
	5 mV/div	99.5 V	97.505 V		101.495 V
	5 mV/div	-99.5 V	-101.495 V		-97.505 V
Channel 2 DC Offset Accuracy, 20 MHz BW, 50 Ω	1 mV/div	900 mV	890.8 mV		909.2 mV
	1 mV/div	-900 mV	-909.2 mV		-890.8 mV
	100 mV/div	5.0 V	4.93 V		5.07 V
	100 mV/div	-5.0 V	-5.07 V		-4.93 V
Channel 2 DC Offset Accuracy, 20 MHz BW, 1 M Ω	1 mV/div	900 mV	890.8 mV		-909.2 mV
	1 mV/div	-900 mV	-909.2 mV		-890.8 mV
	100 mV/div	9.0 V	8.89 V		9.11 V
	100 mV/div	-9.0 V	-9.11 V		-8.89 V
	500 mV/div	9.0 V	8.81 V		9.19 V
	500 mV/div	-9.0 V	-9.19 V		-8.81 V
	1.01 mV/div	99.5 V	98.303 V		100.697 V
	1.01 mV/div	-99.5 V	-100.697 V		-98.303 V
	5 mV/div	99.5 V	97.505 V		101.495 V
	5 mV/div	-99.5 V	-101.495 V		-97.505 V
Channel 3 DC Offset Accuracy, 20 MHz BW, 50 Ω	1 mV/div	900 mV	890.8 mV		909.2 mV
	1 mV/div	-900 mV	-909.2 mV		-890.8 mV
	100 mV/div	5.0 V	4.93 V		5.07 V
	100 mV/div	-5.0 V	-5.07 V		-4.93 V

Offset Accuracy					
Performance checks	Vertical scale	Vertical offset	Low limit	Test result	High limit
Channel 3 DC Offset Accuracy, 20 MHz BW, 1 M Ω	1 mV/div	900 mV	890.8 mV		-909.2 mV
	1 mV/div	-900 mV	-909.2 mV		-890.8 mV
	100 mV/div	9.0 V	8.89 V		9.11 V
	100 mV/div	-9.0 V	-9.11 V		-8.89 V
	500 mV/div	9.0 V	8.81 V		9.19 V
	500 mV/div	-9.0 V	-9.19 V		-8.81 V
	1.01 mV/div	99.5 V	98.303 V		100.697 V
	1.01 mV/div	-99.5 V	-100.697 V		-98.303 V
	5 mV/div	99.5 V	97.505 V		101.495 V
	5 mV/div	-99.5 V	-101.495 V		-97.505 V
Channel 4 DC Offset Accuracy, 20 MHz BW, 50 Ω	1 mV/div	900 mV	890.8 mV		909.2 mV
	1 mV/div	-900 mV	-909.2 mV		-890.8 mV
	100 mV/div	5.0 V	4.93 V		5.07 V
	100 mV/div	-5.0 V	-5.07 V		-4.93 V
Channel 4 DC Offset Accuracy, 20 MHz BW, 1 M Ω	1 mV/div	900 mV	890.8 mV		-909.2 mV
	1 mV/div	-900 mV	-909.2 mV		-890.8 mV
	100 mV/div	9.0 V	8.89 V		9.11 V
	100 mV/div	-9.0 V	-9.11 V		-8.89 V
	500 mV/div	9.0 V	8.81 V		9.19 V
	500 mV/div	-9.0 V	-9.19 V		-8.81 V
	1.01 mV/div	99.5 V	98.303 V		100.697 V
	1.01 mV/div	-99.5 V	-100.697 V		-98.303 V
	5 mV/div	99.5 V	97.505 V		101.495 V
	5 mV/div	-99.5 V	-101.495 V		-97.505 V
6 channel model					
Channel 5 DC Offset Accuracy, 20 MHz BW, 50 Ω	1 mV/div	900 mV	890.8 mV		909.2 mV
	1 mV/div	-900 mV	-909.2 mV		-890.8 mV
	100 mV/div	5.0 V	4.93 V		5.07 V
	100 mV/div	-5.0 V	-5.07 V		-4.93 V

Offset Accuracy					
Performance checks	Vertical scale	Vertical offset	Low limit	Test result	High limit
Channel 5 DC Offset Accuracy, 20 MHz BW, 1 M Ω	1 mV/div	900 mV	890.8 mV		-909.2 mV
	1 mV/div	-900 mV	-909.2 mV		-890.8 mV
	100 mV/div	9.0 V	8.89 V		9.11 V
	100 mV/div	-9.0 V	-9.11 V		-8.89 V
	500 mV/div	9.0 V	8.81 V		9.19 V
	500 mV/div	-9.0 V	-9.19 V		-8.81 V
	1.01 mV/div	99.5 V	98.303 V		100.697 V
	1.01 mV/div	-99.5 V	-100.697 V		-98.303 V
	5 mV/div	99.5 V	97.505 V		101.495 V
	5 mV/div	-99.5 V	-101.495 V		-97.505 V
Channel 6 DC Offset Accuracy, 20 MHz BW, 50 Ω	1 mV/div	900 mV	890.8 mV		909.2 mV
	1 mV/div	-900 mV	-909.2 mV		-890.8 mV
	100 mV/div	5.0 V	4.93 V		5.07 V
	100 mV/div	-5.0 V	-5.07 V		-4.93 V
Channel 6 DC Offset Accuracy, 20 MHz BW, 1 M Ω	1 mV/div	900 mV	890.8 mV		-909.2 mV
	1 mV/div	-900 mV	-909.2 mV		-890.8 mV
	100 mV/div	9.0 V	8.89 V		9.11 V
	100 mV/div	-9.0 V	-9.11 V		-8.89 V
	500 mV/div	9.0 V	8.81 V		9.19 V
	500 mV/div	-9.0 V	-9.19 V		-8.81 V
	1.01 mV/div	99.5 V	98.303 V		100.697 V
	1.01 mV/div	-99.5 V	-100.697 V		-98.303 V
	5 mV/div	99.5 V	97.505 V		101.495 V
	5 mV/div	-99.5 V	-101.495 V		-97.505 V

Analog Bandwidth test record

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 1	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 1	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 2	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 2	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 3	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 3	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	V _{in} -pp	V _{bw} -pp	Limit	Test result Gain = V _{bw} -pp / V _{in} -pp
Channel 4		1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 4	1 MΩ, typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 5	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 5	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V _{bw-pp} / V _{in-pp}
Channel 6	50 Ω	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 6	1 MΩ, typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	
1 GHz models							

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 1	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 1	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 2	50 Ω	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 2	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 3	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 3	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 4	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 4	1 MΩ, typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

1 GHz MSO46

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 5	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 5	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 6	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 6	1 MΩ, typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	
500 MHz models							

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 1	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 1	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 2	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 2	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 3	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 3	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V _{bw-pp} / V _{in-pp}
Channel 4		1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 4	1 MΩ, typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	
500 MHz models (MSO46)							

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 5	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 5	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V _{bw-pp} / V _{in-pp}
Channel 6	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 6	1 MΩ, typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	
350 MHz models							

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 1	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 1	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 2	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 2	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 3	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 3	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 4	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 4	1 MΩ, typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	
Six channel models (MSO46)							

Analog Bandwidth performance checks						
Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}	
1 mV/div	5 ns/div (Full BW)			≥ 0.707		
2 mV/div	2.5 ns/div (Full BW)			≥ 0.707		
5 mV/div	1 ns/div (Full BW)			≥ 0.707		
10 mV/div	1 ns/div (Full BW)			≥ 0.707		
50 mV/div	1 ns/div (Full BW)			≥ 0.707		
100 mV/div	1 ns/div (Full BW)			≥ 0.707		
1 V/div	1 ns/div (Full BW)			≥ 0.707		
1 mV/div	5 ns/div (500 MHz)			≥ 0.707		
2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707		
5 mV/div	1 ns/div (500 MHz)			≥ 0.707		
10 mV/div	1 ns/div (500 MHz)			≥ 0.707		
50 mV/div	1 ns/div (500 MHz)			≥ 0.707		
100 mV/div	1 ns/div (500 MHz)			≥ 0.707		
1 V/div	1 ns/div (500 MHz)			≥ 0.707		

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 6	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 6	1 MΩ, typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	
200 MHz							

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 1	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 1	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 2	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 2	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 3	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 3	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V _{bw-pp} / Vin-pp
Channel 4	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 4	1 MΩ, typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	
Six channel models (MSO46)							

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 5	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 5	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Analog Bandwidth performance checks							
Bandwidth at Channel	Impedance	Vertical scale	Horizontal scale	Vin-pp	Vbw-pp	Limit	Test result Gain = V_{bw-pp} / V_{in-pp}
Channel 6	50 Ω	1 mV/div	5 ns/div (Full BW)			≥ 0.707	
		2 mV/div	2.5 ns/div (Full BW)			≥ 0.707	
		5 mV/div	1 ns/div (Full BW)			≥ 0.707	
		10 mV/div	1 ns/div (Full BW)			≥ 0.707	
		50 mV/div	1 ns/div (Full BW)			≥ 0.707	
		100 mV/div	1 ns/div (Full BW)			≥ 0.707	
		1 V/div	1 ns/div (Full BW)			≥ 0.707	
Channel 6	1 M Ω , typical	1 mV/div	5 ns/div (500 MHz)			≥ 0.707	
		2 mV/div	2.5 ns/div (500 MHz)			≥ 0.707	
		5 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		10 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		50 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		100 mV/div	1 ns/div (500 MHz)			≥ 0.707	
		1 V/div	1 ns/div (500 MHz)			≥ 0.707	

Random Noise High Res acquisition mode test record

MSO44 and MSO46 Random Noise High Res acquisition mode test record

The following test record tables support 4 Series MSO models (MSO44 and MSO46).

Random Noise, Sample acquisition mode: MSO44 and MSO46 1.5 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
		Full		0.259		0.635

MSO44, MSO 46 Channel 1	1 mV/div	250 MHz limit				
		20 MHz				
	2 mV/div	Full		0.259		0.635
		250 MHz limit				
		20 MHz				
	5 mV/div	Full		0.271		0.817
		250 MHz limit				
		20 MHz				
	10 mV/div	Full		0.298		0.843
		250 MHz limit				
		20 MHz				
	20 mV/div	Full		0.363		0.92
		250 MHz limit				
		20 MHz				
	50 mV/div	Full		0.674		1.582
		250 MHz limit				
		20 MHz				
	100 mV/div	Full		1.609		3.686
		250 MHz limit				
		20 MHz				
	1 V/div	Full		18.561		23.753
		250 MHz limit				
		20 MHz				
MSO44, MSO 46 Channel 2	1 mV/div	Full		0.259		0.635
		250 MHz limit				
		20 MHz				
	2 mV/div	Full		0.259		0.635
		250 MHz limit				
		20 MHz				
	5 mV/div	Full		0.271		0.817
		250 MHz limit				
		20 MHz				
	10 mV/div	Full		0.298		0.843

		250 MHz limit				
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Random Noise, Sample acquisition mode: MSO44 and MSO46 1.5 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	20 mV/div	20 MHz				
		Full		0.363		0.92
		250 MHz limit				
	50 mV/div	20 MHz				
		Full		0.674		1.582
		250 MHz limit				
	100 mV/div	20 MHz				
		Full		1.609		3.686
		250 MHz limit				
	1 V/div	20 MHz				
		Full		18.561		23.753
		250 MHz limit				
MSO44, MSO46 Channel 3	1 mV/div	20 MHz				
		Full		0.259		0.635
		250 MHz limit				
	2 mV/div	20 MHz				
		Full		0.259		0.635
		250 MHz limit				
	5 mV/div	20 MHz				
		Full		0.271		0.817
		250 MHz limit				
	10 mV/div	20 MHz				
		Full		0.298		0.843
		250 MHz limit				
	20 mV/div	20 MHz				
		Full		0.363		0.92
		250 MHz limit				

	50 mV/div	Full		0.674		1.582
		250 MHz limit				
		20 MHz				
	100 mV/div	Full		1.609		3.686
		250 MHz limit				
		20 MHz				
	1 V/div	Full		18.561		23.753

Random Noise, Sample acquisition mode: MSO44 and MSO46 1.5 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
MSO44, MSO46 Channel 4		250 MHz limit				
		20 MHz				
	1 mV/div	Full		0.259		0.635
		250 MHz limit				
		20 MHz				
	2 mV/div	Full		0.259		0.635
		250 MHz limit				
		20 MHz				
	5 mV/div	Full		0.271		0.817
		250 MHz limit				
		20 MHz				
	10 mV/div	Full		0.298		0.843
		250 MHz limit				
		20 MHz				
	20 mV/div	Full		0.363		0.92
		250 MHz limit				
		20 MHz				
	50 mV/div	Full		0.674		1.582
		250 MHz limit				
		20 MHz				
		Full		1.609		3.686
		250 MHz limit				

	100 mV/div					
		20 MHz				
	1 V/div	Full		18.561		23.753
		250 MHz limit				
		20 MHz				
	MSO46 Channel 5	1 mV/div	Full		0.259	0.635
			250 MHz limit			
			20 MHz			
		2 mV/div	Full		0.259	0.635
			250 MHz limit			
			20 MHz			
		5 mV/div	Full		0.271	0.817
			250 MHz limit			
			20 MHz			

Random Noise, Sample acquisition mode: MSO44 and MSO46 1.5 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	10 mV/div	Full		0.298		0.843
		250 MHz limit				
		20 MHz				
	20 mV/div	Full		0.363		0.92
		250 MHz limit				
		20 MHz				
	50 mV/div	Full		0.674		1.582
		250 MHz limit				
		20 MHz				
	100 mV/div	Full		1.609		3.686
		250 MHz limit				
		20 MHz				
	1 V/div	Full		18.561		23.753
		250 MHz limit				
		20 MHz				

MSO46 Channel 6	1 mV/div	Full		0.259		0.635
		250 MHz limit				
		20 MHz				
	2 mV/div	Full		0.259		0.635
		250 MHz limit				
		20 MHz				
	5 mV/div	Full		0.271		0.817
		250 MHz limit				
		20 MHz				
	10 mV/div	Full		0.298		0.843
		250 MHz limit				
		20 MHz				
	20 mV/div	Full		0.363		0.92
		250 MHz limit				
		20 MHz				
	50 mV/div	Full		0.674		1.582
		250 MHz limit				
		20 MHz				
	100 mV/div	Full		1.609		3.686
		250 MHz limit				

Random Noise, Sample acquisition mode: MSO44 and MSO46 1.5 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	1 V/div	20 MHz				
		Full		18.561		23.753
		250 MHz limit				
		20 MHz				

Random Noise, High Res acquisition mode: MSO44 and MSO46 1 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
1 GHz models (all models)						
MSO44, MSO46 Channel 1	1 mV/div	Full		0.259		0.336
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.259		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.271		0.394
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.298		0.434
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.363		0.551
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.674		1.038
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.609		2.102
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		18.561		16.874
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906
MSO44, MSO46 Channel 2	1 mV/div	Full		0.259		0.336
		250 MHz limit		0.155		0.161

Random Noise, High Res acquisition mode: MSO44 and MSO46 1 GHz models

Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
MSO44, MSO46 Channel 3		20 MHz		0.096		0.096
		Full		0.259		0.363
		250 MHz limit		0.155		0.161
	2 mV/div	20 MHz		0.096		0.096
		Full		0.271		0.394
		250 MHz limit		0.168		0.174
	5 mV/div	20 MHz		0.096		0.096
		Full		0.298		0.434
		250 MHz limit		0.194		0.206
	10 mV/div	20 MHz		0.103		0.103
		Full		0.363		0.551
		250 MHz limit		0.259		0.298
	20 mV/div	20 MHz		0.129		0.141
		Full		0.674		1.038
		250 MHz limit		0.531		0.596
	50 mV/div	20 MHz		0.233		0.259
		Full		1.609		2.102
		250 MHz limit		1.206		1.349
	100 mV/div	20 MHz		0.596		0.609
		Full		18.561		16.874
		250 MHz limit		13.369		11.617
	1 V/div	20 MHz		7.074		4.906
MSO44, MSO46 Channel 3	1 mV/div	Full		0.259		0.336
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.259		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.271		0.394
		250 MHz limit		0.168		0.174

		20 MHz		0.096		0.096
	10 mV/div	Full		0.298		0.434
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.363		0.551

Random Noise, High Res acquisition mode: MSO44 and MSO46 1 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.674		1.038
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.609		2.102
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		18.561		16.874
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906
MSO44, MSO46	1 mV/div	Full		0.259		0.336
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.259		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.271		0.394
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.298		0.434
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103

Channel 4	20 mV/div	Full		0.363		0.551
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.674		1.038
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.609		2.102
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		18.561		16.874
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906

Random Noise, High Res acquisition mode: MSO44 and MSO46 1 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
1 GHz models (6 channel model)						
MSO46 Channel 5	1 mV/div	Full		0.259		0.336
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.259		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.271		0.394
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.298		0.434
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.363		0.551
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
		Full		0.674		1.038

	50 mV/div	250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.609		2.102
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		18.561		16.874
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906
MSO46 Chan nel 6	1 mV/div	Full		0.259		0.336
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.259		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.271		0.394
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.298		0.434

Random Noise, High Res acquisition mode: MSO44 and MSO46 1 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.363		0.551
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.674		1.038
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.609		2.102
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		18.561		16.874
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906

Random Noise, High Res acquisition mode: MSO44 and MSO46 500 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
500 MHz models (all models)						
MSO44, MSO46 Channel 1	1 mV/div	Full		0.259		0.259
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.259		0.259
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.271		0.304
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.298		0.356
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.363		0.466
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.674		1.038

Random Noise, High Res acquisition mode: MSO44 and MSO46 500 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.609		1.596
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		18.561		12.85
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906

MSO44, MSO46 Channel 2	1 mV/div	Full		0.259		0.259
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.259		0.259
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.271		0.304
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.298		0.356
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.363		0.466
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.674		1.038
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.609		1.596
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		18.561		12.85
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906
MSO44, MSO46 Channel 3	1 mV/div	Full		0.259		0.259
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096

Random Noise, High Res acquisition mode: MSO44 and MSO46 500 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	2 mV/div	Full		0.259		0.259
		250 MHz limit		0.155		0.161

		20 MHz		0.096		0.096
		Full		0.271		0.304
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
		Full		0.298		0.356
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
		Full		0.363		0.466
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.674		1.038
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.609		1.596
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		18.561		12.85
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906
MSO44, MSO46 Channel 4	1 mV/div	Full		0.259		0.259
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.259		0.259
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.271		0.304
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.298		0.356
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.363		0.466
		250 MHz limit		0.259		0.298

Random Noise, High Res acquisition mode: MSO44 and MSO46 500 MHz models						
Performance Checks			1 MΩ		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	50 mV/div	20 MHz		0.129		0.141
		Full		0.674		1.038
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.609		1.596
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		18.561		12.85
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906
500 MHz models (6 channel model)						
MSO46 Channel 5	1 mV/div	Full		0.259		0.259
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.259		0.259
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.271		0.304
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.298		0.356
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.363		0.466
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.674		1.038
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
		Full		1.609		1.596

	100 mV/div	250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		18.561		12.85
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906

Random Noise, High Res acquisition mode: MSO44 and MSO46 500 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
MSO46 Channel 6	1 mV/div	Full		0.259		0.259
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.259		0.259
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.271		0.304
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.298		0.356
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.363		0.466
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.674		1.038
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.609		1.596
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		18.561		12.85
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906

Random Noise, High Res acquisition mode: MSO44 and MSO46 350 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
350 MHz models (all models)						
MSO44, MSO46 Channel 1	1 mV/div	Full		0.181		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.181		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096

Random Noise, High Res acquisition mode: MSO44 and MSO46 350 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	5 mV/div	Full		0.194		0.239
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.206		0.284
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.259		0.349
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.479		0.139
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.141		1.349
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		13.239		11.617
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906

MSO44, MSO46 Channel 2	1 mV/div	Full		0.181		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.181		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.194		0.239
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.206		0.284
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.259		0.349
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.479		0.139
		250 MHz limit		0.531		0.596

Random Noise, High Res acquisition mode: MSO44 and MSO46 350 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	100 mV/div	20 MHz		0.233		0.259
		Full		1.141		1.349
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		13.239		11.617
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906
	1 mV/div	Full		0.181		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.181		0.194
		250 MHz limit		0.155		0.161

MSO44, MSO46 Channel 3		20 MHz		0.096		0.096
	5 mV/div	Full		0.194		0.239
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.206		0.284
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.259		0.349
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.479		0.139
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.141		1.349
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		13.239		11.617
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906
MSO44, MSO 46 Channel 4	1 mV/div	Full		0.181		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.181		0.194

Random Noise, High Res acquisition mode: MSO44 and MSO46 350 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.194		0.239
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
		Full		0.206		0.284

	10 mV/div	250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.259		0.349
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.479		0.139
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.141		1.349
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609
	1 V/div	Full		13.239		11.617
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906

350 MHz models (6 channel model)

MSO46 Channel 5	1 mV/div	Full		0.181		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.181		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.194		0.239
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.206		0.284
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.259		0.349
		250 MHz limit		0.259		0.298

Random Noise, High Res acquisition mode: MSO44 and MSO46 350 MHz models

Performance Checks	1 MΩ	50 Ω
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Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	50 mV/div	20 MHz		0.129		0.141
		Full		0.479		0.139
		250 MHz limit		0.531		0.596
	100 mV/div	20 MHz		0.233		0.259
		Full		1.141		1.349
		250 MHz limit		1.206		1.349
	1 V/div	20 MHz		0.596		0.609
		Full		13.239		11.617
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906
MSO46 Channel 6	1 mV/div	Full		0.181		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	2 mV/div	Full		0.181		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.096		0.096
	5 mV/div	Full		0.194		0.239
		250 MHz limit		0.168		0.174
		20 MHz		0.096		0.096
	10 mV/div	Full		0.206		0.284
		250 MHz limit		0.194		0.206
		20 MHz		0.103		0.103
	20 mV/div	Full		0.259		0.349
		250 MHz limit		0.259		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.479		0.139
		250 MHz limit		0.531		0.596
		20 MHz		0.233		0.259
	100 mV/div	Full		1.141		1.349
		250 MHz limit		1.206		1.349
		20 MHz		0.596		0.609

	1 V/div	Full		13.239		11.617
		250 MHz limit		13.369		11.617
		20 MHz		7.074		4.906

MSO44B and MSO46B Random Noise High Res acquisition mode test record

The following test record tables support 4 Series B MSO models (MSO44B and MSO46B).

Random Noise, Sample acquisition mode: MSO44B and MSO46B 1.5 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
MSO44B, MSO46B Channel 1	1 mV/div	Full		0.259		0.674
		250 MHz limit				
		20 MHz				
	2 mV/div	Full		0.271		0.674
		250 MHz limit				
		20 MHz				
	5 mV/div	Full		0.284		0.804
		250 MHz limit				
		20 MHz				
	10 mV/div	Full		0.298		0.804
		250 MHz limit				
		20 MHz				
	20 mV/div	Full		0.389		0.933
		250 MHz limit				
		20 MHz				
	50 mV/div	Full		0.713		1.687
		250 MHz limit				
		20 MHz				
	100 mV/div	Full		1.752		3.894
		250 MHz limit				
		20 MHz				
	1 V/div	Full		19.47		27.258
		250 MHz limit				
		20 MHz				

MSO44B, MSO46B Channel 2	1 mV/div	Full		0.259		0.674
		250 MHz limit				
		20 MHz				
	2 mV/div	Full		0.271		0.674
		250 MHz limit				
		20 MHz				
	5 mV/div	Full		0.284		0.804
		250 MHz limit				
		20 MHz				

Random Noise, Sample acquisition mode: MSO44B and MSO46B 1.5 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	10 mV/div	Full		0.298		0.804
		250 MHz limit				
		20 MHz				
	20 mV/div	Full		0.389		0.933
		250 MHz limit				
		20 MHz				
	50 mV/div	Full		0.713		1.687
		250 MHz limit				
		20 MHz				
	100 mV/div	Full		1.752		3.894
		250 MHz limit				
		20 MHz				
	1 V/div	Full		19.47		27.258
		250 MHz limit				
		20 MHz				
		Full		0.259		0.674

MSO44B, MSO46B Channel 3	1 mV/div	250 MHz limit				
		20 MHz				
	2 mV/div	Full		0.271		0.674
		250 MHz limit				
		20 MHz				
	5 mV/div	Full		0.284		0.804
		250 MHz limit				
		20 MHz				
	10 mV/div	Full		0.298		0.804
		250 MHz limit				
		20 MHz				
	20 mV/div	Full		0.389		0.933
		250 MHz limit				
		20 MHz				
	50 mV/div	Full		0.713		1.687
		250 MHz limit				
		20 MHz				
	100 mV/div	Full		1.752		3.894
		250 MHz limit				

Random Noise, Sample acquisition mode: MSO44B and MSO46B 1.5 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	1 V/div	20 MHz				
		Full		19.47		27.258
		250 MHz limit				
		20 MHz				
	1 mV/div	Full		0.259		0.674
		250 MHz limit				

MSO44B, MS O46B Channel 4		20 MHz				
	2 mV/div	Full		0.271		0.674
		250 MHz limit				
		20 MHz				
	5 mV/div	Full		0.284		0.804
		250 MHz limit				
		20 MHz				
	10 mV/div	Full		0.298		0.804
		250 MHz limit				
		20 MHz				
	20 mV/div	Full		0.389		0.933
		250 MHz limit				
		20 MHz				
	50 mV/div	Full		0.713		1.687
		250 MHz limit				
		20 MHz				
	100 mV/div	Full		1.752		3.894
		250 MHz limit				
		20 MHz				
	1 V/div	Full		19.47		27.258
		250 MHz limit				
		20 MHz				
MSO46B Channel 5	1 mV/div	Full		0.259		0.674
		250 MHz limit				
		20 MHz				
	2 mV/div	Full		0.271		0.674
		250 MHz limit				
		20 MHz				
	5 mV/div	Full		0.284		0.804

Random Noise, Sample acquisition mode: MSO44B and MSO46B 1.5 GHz models

Performance Checks

1 M Ω

50 Ω

Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
		250 MHz limit				
		20 MHz				
	10 mV/div	Full		0.298		0.804
		250 MHz limit				
		20 MHz				
	20 mV/div	Full		0.389		0.933
		250 MHz limit				
		20 MHz				
	50 mV/div	Full		0.713		1.687
		250 MHz limit				
		20 MHz				
	100 mV/div	Full		1.752		3.894
		250 MHz limit				
		20 MHz				
	1 V/div	Full		19.47		27.258
		250 MHz limit				
		20 MHz				
MSO46B Channel 6	1 mV/div	Full		0.259		0.674
		250 MHz limit				
		20 MHz				
	2 mV/div	Full		0.271		0.674
		250 MHz limit				
		20 MHz				
	5 mV/div	Full		0.284		0.804
		250 MHz limit				
		20 MHz				
	10 mV/div	Full		0.298		0.804
		250 MHz limit				
		20 MHz				
	20 mV/div	Full		0.389		0.933
		250 MHz limit				

		20 MHz				
	50 mV/div	Full		0.713		1.687
		250 MHz limit				
		20 MHz				

Random Noise, Sample acquisition mode: MSO44B and MSO46B 1.5 GHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	100 mV/div	Full		1.752		3.894
		250 MHz limit				
		20 MHz				
	1 V/div	Full		19.47		27.258
		250 MHz limit				
		20 MHz				

Random Noise, High Res acquisition mode: MSO44B and MSO46B 1 GHz models						
Performance Checks			1 M Ω		50 Ω	
	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
1 GHz models (all models)						
MSO44B, MSO46B Channel 1	1 mV/div	Full		0.259		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.271		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.284		0.389
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.298		0.427
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.389		0.544
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.713		1.038
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.752		2.141
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		19.47		16.874
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906

Random Noise, High Res acquisition mode: MSO44B and MSO46B 1 GHz models						
Performance Checks			1 M Ω		50 Ω	
	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)

MSO44B, MS O46B Channel 2	1 mV/div	Full		0.259		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.271		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.284		0.389
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.298		0.427
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.389		0.544
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.713		1.038
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.752		2.141
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		19.47		16.874
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906
MSO44B, MS O46B Channel 3	1 mV/div	Full		0.259		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.271		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.284		0.389
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096

	10 mV/div	Full		0.298		0.427
		250 MHz limit		0.194		0.206

Random Noise, High Res acquisition mode: MSO44B and MSO46B 1 GHz models

Performance Checks			1 M Ω		50 Ω	
	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	20 mV/div	20 MHz		0.096		0.103
		Full		0.389		0.544
		250 MHz limit		0.284		0.298
	50 mV/div	20 MHz		0.129		0.141
		Full		0.713		1.038
		250 MHz limit		0.584		0.596
	100 mV/div	20 MHz		0.259		0.259
		Full		1.752		2.141
		250 MHz limit		1.336		1.349
	1 V/div	20 MHz		0.622		0.609
		Full		19.47		16.874
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906
		Full		0.259		0.363
		250 MHz limit		0.155		0.161
MSO44B, MSO46B Channel 4	1 mV/div	20 MHz		0.090		0.096
		Full		0.271		0.363
		250 MHz limit		0.155		0.161
	2 mV/div	20 MHz		0.090		0.096
		Full		0.284		0.389
		250 MHz limit		0.168		0.174
	5 mV/div	20 MHz		0.090		0.096
		Full		0.298		0.427
		250 MHz limit		0.194		0.206
	10 mV/div	20 MHz		0.096		0.103
		Full		0.389		0.544
		250 MHz limit		0.284		0.298

		20 MHz		0.129		0.141
	50 mV/div	Full		0.713		1.038
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.752		2.141
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		19.47		16.874

Random Noise, High Res acquisition mode: MSO44B and MSO46B 1 GHz models						
Performance Checks			1 M Ω		50 Ω	
	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906
1 GHz models (6 channel model)						
MSO46B Channel 5	1 mV/div	Full		0.259		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.271		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.284		0.389
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.298		0.427
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.389		0.544
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.713		1.038
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259

	100 mV/div	Full		1.752		2.141
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		19.47		16.874
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906
MSO46B Channel 6	1 mV/div	Full		0.259		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.271		0.363
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.284		0.389
		250 MHz limit		0.168		0.174

Random Noise, High Res acquisition mode: MSO44B and MSO46B 1 GHz models

Performance Checks			1 M Ω		50 Ω	
	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
		20 MHz		0.090		0.096
	10 mV/div	Full		0.298		0.427
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.389		0.544
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.713		1.038
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.752		2.141
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		19.47		16.874
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906

Random Noise, High Res acquisition mode: MSO44B and MSO46B 500 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
500 MHz models (all models)						
MSO44B, MSO46B Channel 1	1 mV/div	Full		0.259		0.271
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.271		0.271
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.284		0.298
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.298		0.336
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.389		0.454
		250 MHz limit		0.284		0.298

Random Noise, High Res acquisition mode: MSO44B and MSO46B 500 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	50 mV/div	20 MHz		0.129		0.141
		Full		0.713		1.012
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.752		1.674
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		19.47		12.98
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906

MSO44B, MSO46B Channel 2	1 mV/div	Full		0.259		0.271
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.271		0.271
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.284		0.298
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.298		0.336
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.389		0.454
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.713		1.012
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.752		1.674
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		19.47		12.98
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906

Random Noise, High Res acquisition mode: MSO44B and MSO46B 500 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	1 mV/div	Full		0.259		0.271
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.271		0.271
		250 MHz limit		0.155		0.161

MSO44B, MS O46B Channel 3		20 MHz		0.090		0.096
	5 mV/div	Full		0.284		0.298
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.298		0.336
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.389		0.454
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.713		1.012
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.752		1.674
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		19.47		12.98
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906
MSO44B, MS O46B Channel 4	1 mV/div	Full		0.259		0.271
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.271		0.271
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.284		0.298
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.298		0.336
		250 MHz limit		0.194		0.206

Random Noise, High Res acquisition mode: MSO44B and MSO46B 500 MHz models

Performance Checks

1 M Ω

50 Ω

Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	20 mV/div	20 MHz		0.096		0.103
		Full		0.389		0.454
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.713		1.012
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.752		1.674
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		19.47		12.98
		250 MHz limit		14.927		11.617
20 MHz			7.528		4.906	
500 MHz models (6 channel model)						
MSO46B Channel 5	1 mV/div	Full		0.259		0.271
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.271		0.271
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.284		0.298
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.298		0.336
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.389		0.454
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.713		1.012
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259

	100 mV/div	Full		1.752		1.674
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609

Random Noise, High Res acquisition mode: MSO44B and MSO46B 500 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	1 V/div	Full		19.47		12.98
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906
MSO46B Channel 6	1 mV/div	Full		0.259		0.271
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.271		0.271
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.284		0.298
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.298		0.336
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.389		0.454
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.713		1.012
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.752		1.674
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		19.47		12.98
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906

Random Noise, High Res acquisition mode: MSO44B and MSO46B 350 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
350 MHz models (all models)						
MSO44B, MSO46B Channel 1	1 mV/div	Full		0.194		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096

Random Noise, High Res acquisition mode: MSO44B and MSO46B 350 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	2 mV/div	Full		0.194		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.206		0.239
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.220		0.284
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.298		0.349
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.584		0.739
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.298		1.349
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		14.927		11.617
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906

MSO44B, MSO46B Channel 2	1 mV/div	Full		0.194		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.194		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.206		0.239
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.220		0.284
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.298		0.349
		250 MHz limit		0.284		0.298

Random Noise, High Res acquisition mode: MSO44B and MSO46B 350 MHz models						
Performance Checks			1 MΩ		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	50 mV/div	20 MHz		0.129		0.141
		Full		0.584		0.739
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.298		1.349
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		14.927		11.617
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906
	1 mV/div	Full		0.194		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.194		0.194
		250 MHz limit		0.155		0.161

MSO44B, MSO46B Channel 3		20 MHz		0.090		0.096
	5 mV/div	Full		0.206		0.239
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.220		0.284
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.298		0.349
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.584		0.739
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.298		1.349
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		14.927		11.617
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906

Random Noise, High Res acquisition mode: MSO44B and MSO46B 350 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	1 mV/div	Full		0.194		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.194		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.206		0.239
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
		Full		0.220		0.284

MSO44B, MSO46B Channel 4	10 mV/div	250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.298		0.349
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.584		0.739
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.298		1.349
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609
	1 V/div	Full		14.927		11.617
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906

350 MHz models (6 channel model)

MSO46B Channel 5	1 mV/div	Full		0.194		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.194		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.206		0.239
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.220		0.284

Random Noise, High Res acquisition mode: MSO44B and MSO46B 350 MHz models

Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.298		0.349
		250 MHz limit		0.284		0.298

		20 MHz		0.129		0.141
		50 mV/div	Full		0.584	0.739
			250 MHz limit		0.584	0.596
			20 MHz		0.259	0.259
		100 mV/div	Full		1.298	1.349
			250 MHz limit		1.336	1.349
			20 MHz		0.622	0.609
		1 V/div	Full		14.927	11.617
			250 MHz limit		14.927	11.617
			20 MHz		7.528	4.906
MSO46B Channel 6	1 mV/div	Full		0.194		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	2 mV/div	Full		0.194		0.194
		250 MHz limit		0.155		0.161
		20 MHz		0.090		0.096
	5 mV/div	Full		0.206		0.239
		250 MHz limit		0.168		0.174
		20 MHz		0.090		0.096
	10 mV/div	Full		0.220		0.284
		250 MHz limit		0.194		0.206
		20 MHz		0.096		0.103
	20 mV/div	Full		0.298		0.349
		250 MHz limit		0.284		0.298
		20 MHz		0.129		0.141
	50 mV/div	Full		0.584		0.739
		250 MHz limit		0.584		0.596
		20 MHz		0.259		0.259
	100 mV/div	Full		1.298		1.349
		250 MHz limit		1.336		1.349
		20 MHz		0.622		0.609

Random Noise, High Res acquisition mode: MSO44B and MSO46B 350 MHz models						
Performance Checks			1 M Ω		50 Ω	
Channel	V/div	Bandwidth	Test result (mV)	High limit (mV)	Test result (mV)	High limit (mV)
	1 V/div	Full		14.927		11.617
		250 MHz limit		14.927		11.617
		20 MHz		7.528		4.906

Long term sample rate through AFG DC offset accuracy test records

Long Term Sample Rate			
Performance checks	Low limit	Test result	High limit
Long Term Sample Rate	-2 divisions		+2 divisions

Digital Threshold Accuracy, typical						
Performance checks:						
Digital channel	Threshold	Vs–	Vs+	Low limit	Test result	High limit
All models						
Channel 1						
D0	0 V			-0.1 V		0.1 V
D1	0 V			-0.1 V		0.1 V
D2	0 V			-0.1 V		0.1 V
D3	0 V			-0.1 V		0.1 V
D4	0 V			-0.1 V		0.1 V
D5	0 V			-0.1 V		0.1 V
D6	0 V			-0.1 V		0.1 V
D7	0 V			-0.1 V		0.1 V
Channel 2						
D0	0 V			-0.1 V		0.1 V
D1	0 V			-0.1 V		0.1 V
D2	0 V			-0.1 V		0.1 V
D3	0 V			-0.1 V		0.1 V
D4	0 V			-0.1 V		0.1 V
D5	0 V			-0.1 V		0.1 V
D6	0 V			-0.1 V		0.1 V
D7	0 V			-0.1 V		0.1 V
Channel 3						
D0	0 V			-0.1 V		0.1 V
D1	0 V			-0.1 V		0.1 V

Digital Threshold Accuracy, typical						
Performance checks:						
Digital channel	Threshold	Vs–	Vs+	Low limit	Test result	High limit
D2	0 V			-0.1 V		0.1 V
D3	0 V			-0.1 V		0.1 V
D4	0 V			-0.1 V		0.1 V

D5	0 V			-0.1 V		0.1 V
D6	0 V			-0.1 V		0.1 V
D7	0 V			-0.1 V		0.1 V
Channel 4						
D0	0 V			-0.1 V		0.1 V
D1	0 V			-0.1 V		0.1 V
D2	0 V			-0.1 V		0.1 V
D3	0 V			-0.1 V		0.1 V
D4	0 V			-0.1 V		0.1 V
D5	0 V			-0.1 V		0.1 V
D6	0 V			-0.1 V		0.1 V
D7	0 V			-0.1 V		0.1 V
All 6 channel models						
Channel 5						
D0	0 V			-0.1 V		0.1 V
D1	0 V			-0.1 V		0.1 V
D2	0 V			-0.1 V		0.1 V
D3	0 V			-0.1 V		0.1 V
D4	0 V			-0.1 V		0.1 V
D5	0 V			-0.1 V		0.1 V
D6	0 V			-0.1 V		0.1 V
D7	0 V			-0.1 V		0.1 V
Channel 6						
D0	0 V			-0.1 V		0.1 V
D1	0 V			-0.1 V		0.1 V
D2	0 V			-0.1 V		0.1 V
D3	0 V			-0.1 V		0.1 V
D4	0 V			-0.1 V		0.1 V
D5	0 V			-0.1 V		0.1 V
D6	0 V			-0.1 V		0.1 V
D7	0 V			-0.1 V		0.1 V

AUX Out output voltage levels				
Performance checks	Vout	Low limit	Test result	High limit
Output levels, 1 M Ω input impedance	Max	$\geq 2.5\text{ V}$		n/a
	Min	n/a		$\leq 700\text{ mV}$
Output levels, 50 Ω Input Impedance,	Max	$\geq 1\text{ V}$		n/a
	Min	n/a		$\leq 250\text{ mV}$

DVM voltage accuracy (DC)					
Channel 1					
Vertical Scale	Input Voltage	Offset Voltage	Low limit	Test result	High limit
1	−5	−5	-5.125		-4.875
0.5	−2	−2	-2.06		-1.94
0.5	−1	−0.5	-1.06		-0.94
0.2	−0.5	−0.5	-0.5225		-0.4775
0.01	0.002	0	0.00097		0.00303
0.2	0.5	0.5	0.4775		0.5225
0.5	1	0.5	0.94		1.06
0.5	2	2	1.94		2.06
1	5	5	4.875		5.125
Channel 2					
Vertical Scale	Input Voltage	Offset Voltage	Low limit	Test result	High limit
1	−5	−5	-5.125		-4.875
0.5	−2	−2	-2.06		-1.94
0.5	−1	−0.5	-1.06		-0.94
0.2	−0.5	−0.5	-0.5225		-0.4775
0.01	0.002	0	0.00097		0.00303
0.2	0.5	0.5	0.4775		0.5225
0.5	1	0.5	0.94		1.06
0.5	2	2	1.94		2.06
1	5	5	4.875		5.125
Channel 3					
Vertical Scale	Input Voltage	Offset Voltage	Low limit	Test result	High limit
1	-5	-5	-5.125		-4.875
0.5	-2	-2	-2.06		-1.94
0.5	-1	-0.5	-1.06		-0.94
0.2	-0.5	-0.5	-0.5225		-0.4775
0.01	0.002	0	0.00097		0.00303
0.2	0.5	0.5	0.4775		0.5225

DVM voltage accuracy (DC)					
0.5	1	0.5	0.94		1.06
0.5	2	2	1.94		2.06
1	5	5	4.875		5.125
Channel 4					
Vertical Scale	Input Voltage	Offset Voltage	Low limit	Test result	High limit
1	-5	-5	-5.125		-4.875
0.5	-2	-2	-2.06		-1.94
0.5	-1	-0.5	-1.06		-0.94
0.2	-0.5	-0.5	-0.5225		-0.4775
0.01	0.002	0	0.00097		0.00303
0.2	0.5	0.5	0.4775		0.5225
0.5	1	0.5	0.94		1.06
0.5	2	2	1.94		2.06
1	5	5	4.875		5.125

DVM voltage accuracy (DC)					
6 channel model					
Channel 5					
Vertical Scale	Input Voltage	Offset Voltage	Low limit	Test result	High limit
1	-5	-5	-5.125		-4.875
0.5	-2	-2	-2.06		-1.94
0.5	-1	-0.5	-1.06		-0.94
0.2	-0.5	-0.5	-0.5225		-0.4775
0.01	0.002	0	0.00097		0.00303
0.2	0.5	0.5	0.4775		0.5225
0.5	1	0.5	0.94		1.06
0.5	2	2	1.94		2.06
1	5	5	4.875		5.125
Channel 6					
Vertical Scale	Input Voltage	Offset Voltage	Low limit	Test result	High limit
1	-5	-5	-5.125		-4.875
0.5	-2	-2	-2.06		-1.94
0.5	-1	-0.5	-1.06		-0.94
0.2	-0.5	-0.5	-0.5225		-0.4775
0.01	0.002	0	0.00097		0.00303
0.2	0.5	0.5	0.4775		0.5225
0.5	1	0.5	0.94		1.06
0.5	2	2	1.94		2.06

DVM voltage accuracy (DC)					
1	5	5	4.875		5.125

DVM voltage accuracy (AC)				
All models				
Channel 1				
Vertical Scale	Input Signal	Low limit	Test result	High limit
5 mV	20 mV _{pp} at 1 kHz	9.800 mV		10.200 mV
10 mV	50 mV _{pp} at 1 kHz	24.5 mV		25.500 mV

100 mV	0.5 V _{pp} at 1 kHz	245.000 mV		255.000 mV
200 mV	1 V _{pp} at 1 kHz	490.000 mV		510.000 mV
1 V	5 V _{pp} at 1 kHz	2450.0 mV		2550.0 mV
Channel 2				
Vertical Scale	Input Signal	Low limit	Test result	High limit
5 mV	20 mV _{pp} at 1 kHz	9.800 mV		10.200 mV
10 mV	50 mV _{pp} at 1 kHz	24.5 mV		25.500 mV
100 mV	0.5 V _{pp} at 1 kHz	245.000 mV		255.000 mV
200 mV	1 V _{pp} at 1 kHz	490.000 mV		510.000 mV
1 V	5 V _{pp} at 1 kHz	2450.0 mV		2550.0 mV
Channel 3				
Vertical Scale	Input Signal	Low limit	Test result	High limit
5 mV	20 mV _{pp} at 1 kHz	9.800 mV		10.200 mV
10 mV	50 mV _{pp} at 1 kHz	24.5 mV		25.500 mV
100 mV	0.5 V _{pp} at 1 kHz	245.000 mV		255.000 mV
200 mV	1 V _{pp} at 1 kHz	490.000 mV		510.000 mV
1 V	5 V _{pp} at 1 kHz	2450.0 mV		2550.0 mV
Channel 4				
Vertical Scale	Input Signal	Low limit	Test result	High limit
5 mV	20 mV _{pp} at 1 kHz	9.800 mV		10.200 mV
10 mV	50 mV _{pp} at 1 kHz	24.5 mV		25.500 mV
100 mV	0.5 V _{pp} at 1 kHz	245.000 mV		255.000 mV
200 mV	1 V _{pp} at 1 kHz	490.000 mV		510.000 mV
1 V	5 V _{pp} at 1 kHz	2450.0 mV		2550.0 mV
6 channel model				
Channel 5				
Vertical Scale	Input Signal	Low limit	Test result	High limit

DVM voltage accuracy (AC)				
5 mV	20 mV _{pp} at 1 kHz	9.800 mV		10.200 mV
10 mV	50 mV _{pp} at 1 kHz	24.5 mV		25.500 mV
100 mV	0.5 V _{pp} at 1 kHz	245.000 mV		255.000 mV
200 mV	1 V _{pp} at 1 kHz	490.000 mV		510.000 mV
1 V	5 V _{pp} at 1 kHz	2450.0 mV		2550.0 mV
Channel 6				
Vertical Scale	Input Signal	Low limit	Test result	High limit
5 mV	20 mV _{pp} at 1 kHz	9.800 mV		10.200 mV
10 mV	50 mV _{pp} at 1 kHz	24.5 mV		25.500 mV
100 mV	0.5 V _{pp} at 1 kHz	245.000 mV		255.000 mV
200 mV	1 V _{pp} at 1 kHz	490.000 mV		510.000 mV
1 V	5 V _{pp} at 1 kHz	2450.0 mV		2550.0 mV

Trigger frequency accuracy and trigger frequency counter maximum input frequency				
All models				
Channel 1	Hz	Low limit	Test result	High limit
	100 Hz	99.99974 Hz		100.00026 Hz
	1 kHz	999.9974 Hz		1.0000026 KHz
	10 kHz	9.999974 KHz		10.000026 kHz
	100 kHz	99.99974 kHz		100.00026 kHz
	1 MHz	999.9974 kHz		1.0000026 MHz
	10 MHz	9.999974 MHz		10.000026 MHz
	100 MHz	99.99974 MHz		100.00026 MHz
	1 GHz (1 GHz mode ls only)	999.9974 MHz		1.0000026 GHz
	1.5 GHz (1.5 GHz m odels only)	1.499994 GHz		1.5000051 GHz

	Hz	Low limit	Test result	High limit
	100 Hz	99.99974 Hz		100.00026 Hz
	1 kHz	999.9974 Hz		1.0000026 KHz
	10 kHz	9.999974 KHz		10.000026 kHz
	100 kHz	99.99974 kHz		100.00026 kHz

Channel 2	1 MHz	999.9974 kHz		1.0000026 MHz
	10 MHz	9.999974 MHz		10.000026 MHz
	100 MHz	99.99974 MHz		100.00026 MHz
	1 GHz (1 GHz mode ls only)	999.9974 MHz		1.0000026 GHz
	1.5 GHz (1.5 GHz m odels only)	1.499994 GHz		1.5000051 GHz
Channel 3	Hz	Low limit	Test result	High limit
	100 Hz	99.99974 Hz		100.00026 Hz
	1 kHz	999.9974 Hz		1.0000026 KHz
	10 kHz	9.999974 KHz		10.000026 kHz
	100 kHz	99.99974 kHz		100.00026 kHz
	1 MHz	999.9974 kHz		1.0000026 MHz
	10 MHz	9.999974 MHz		10.000026 MHz
	100 MHz	99.99974 MHz		100.00026 MHz
	1 GHz (1 GHz mode ls only)	999.9974 MHz		1.0000026 GHz
	1.5 GHz (1.5 GHz m odels only)	1.499994 GHz		1.5000051 GHz
Channel 4	Hz	Low limit	Test result	High limit
	100 Hz	99.99974 Hz		100.00026 Hz
	1 kHz	999.9974 Hz		1.0000026 KHz
	10 kHz	9.999974 KHz		10.000026 kHz
	100 kHz	99.99974 kHz		100.00026 kHz
	1 MHz	999.9974 kHz		1.0000026 MHz
	10 MHz	9.999974 MHz		10.000026 MHz
	100 MHz	99.99974 MHz		100.00026 MHz
	1 GHz (1 GHz mode ls only)	999.9974 MHz		1.0000026 GHz
	1.5 GHz (1.5 GHz m odels only)	1.499994 GHz		1.5000051 GHz

Trigger frequency accuracy and trigger frequency counter maximum input frequency

6 channel model

Table continued...

Trigger frequency accuracy and trigger frequency counter maximum input frequency				
Channel 5	Hz	Low limit	Test result	High limit
	100 Hz	99.99974 Hz		100.00026 Hz
	1 kHz	999.9974 Hz		1.0000026 KHz
	10 kHz	9.999974 KHz		10.000026 kHz
	100 kHz	99.99974 kHz		100.00026 kHz
	1 MHz	999.9974 kHz		1.0000026 MHz
	10 MHz	9.999974 MHz		10.000026 MHz
	100 MHz	99.99974 MHz		100.00026 MHz
	1 GHz (1 GHz models only)	999.9974 MHz		1.0000026 GHz
	1.5 GHz (1.5 GHz models only)	1.499994 GHz		1.5000051 GHz
Channel 6	Hz	Low limit	Test result	High limit
	100 Hz	99.99974 Hz		100.00026 Hz
	1 kHz	999.9974 Hz		1.0000026 KHz
	10 kHz	9.999974 KHz		10.000026 kHz
	100 kHz	99.99974 kHz		100.00026 kHz
	1 MHz	999.9974 kHz		1.0000026 MHz
	10 MHz	9.999974 MHz		10.000026 MHz
	100 MHz	99.99974 MHz		100.00026 MHz
	1 GHz (1 GHz models only)	999.9974 MHz		1.0000026 GHz
	1.5 GHz (1.5 GHz models only)	1.499994 GHz		1.5000051 GHz

AFG sine and ramp frequency accuracy				
Performance checks				
	Waveform type	Minimum	Test result	Maximum
	Sine	0.999950 MHz		1.000050 MHz
	Ramp	499.975 kHz		500.025 kHz

AFG square and pulse frequency accuracy				
Performance checks				
	Waveform type	Minimum	Test result	Maximum
	Sine	0.999950 MHz		1.000050 MHz
	Pulse	0.999950 MHz		1.000050 MHz

AFG signal amplitude accuracy				
Performance checks				
	Amplitude	Minimum	Test result	Maximum
	30.0 mV _{PP}	28.55 mV _{PP}		31.45 mV _{PP}
	300.0 mV _{PP}	294.5 mV _{PP}		305.5 mV _{PP}
	800.0 mV _{PP}	787.0 mV _{PP}		813.0 mV _{PP}
	1.500 V _{PP}	1.4765 V _{PP}		1.5235 V _{PP}
	2.000 V _{PP}	1.9690 V _{PP}		2.0310 V _{PP}
	2.500 V _{PP}	2.4615 V _{PP}		2.5385 V _{PP}

AFG DC offset accuracy				
Performance checks				
	Offset	Minimum	Test result	Maximum
	1.25 V	1.23025 Vdc		1.26975 Vdc
	0 V	-0.001 Vdc		+0.001 Vdc
	-1.25 V	-1.26975		-1.23025 Vdc

Performance tests

This section contains a collection of manual procedures for checking that the instrument performs as warranted. They check all the characteristics that are designated as checked in Specifications. (The characteristics that are checked appear with a ✓ in Specifications).

Prerequisites

The tests in this section comprise an extensive, valid confirmation of performance and functionality when the following requirements are met:

- The instrument must be in its normal operating configuration (no covers removed).
- You must have performed and passed the procedures under Self Test. (See Self test on page 167.)
- A signal-path compensation must have been done within the recommended calibration interval and at a temperature within ± 5 °C (± 9 °F) of the present operating temperature. (If the temperature was within the limits just stated at the time you did the prerequisite Self Test, consider this prerequisite met). A signal-path

compensation must have been done at an ambient humidity within 25% of the current ambient humidity and after having been at that humidity for at least 4 hours.

- The instrument must have been last adjusted at an ambient temperature between +18 °C and +28 °C (+64 °F and +82 °F), must have been operating for a warm-up period of at least 20 minutes, and must be operating at an ambient temperature as listed in the specifications. The warm-up requirement is usually met in the course of meeting the Self Test prerequisites listed above.
- The instrument must be powered from a source maintaining voltage and frequency within the limits described in the Specifications section.
- The instrument must be in an environment with temperature, altitude, humidity, and vibration within the operating limits described in the Specifications section.


Self test

This procedure verifies that the instrument passes the internal diagnostics and performs signal path compensation. No test equipment or hookups are required.

Equipment required	Prerequisites
None	Power on the instrument and allow a 20 minute warm-up period before performing this procedure.

1. Run the System Diagnostics (may take a few minutes).
 - a. Disconnect all probes and/or cables from the oscilloscope inputs.
 - b. Tap Utility > Self Test. This displays the Self Test configuration menu.
 - c. Tap the Run Self Test button.
 - d. The internal diagnostics perform an exhaustive verification of proper instrument function. This verification may take several minutes. When the verification is finished, the status of each self test is shown in the menu.
 - e. Verify that the status of all tests is passed.
 - f. Tap anywhere outside the menu to exit the menu.
2. Run the signal-path compensation routine (may take 5 to 15 minutes per channel).
 - a. Tap Utility > Calibration. This displays the Calibration configuration menu.
 - b. Tap the Run SPC button to start the routine.
 - c. Signal-path compensation may take 5 to 15 minutes to run per channel.
 - d. Verify that the SPC Status is Passed.
3. Return to regular service: Tap anywhere outside the menu to exit the Calibration menu.

The self test procedures are completed. If any of the above tests failed, run the tests again. If there are still failures, contact Tektronix Customer Support.

 **Note:** You cannot run the remaining performance tests until the self tests pass and the SPC has successfully run.

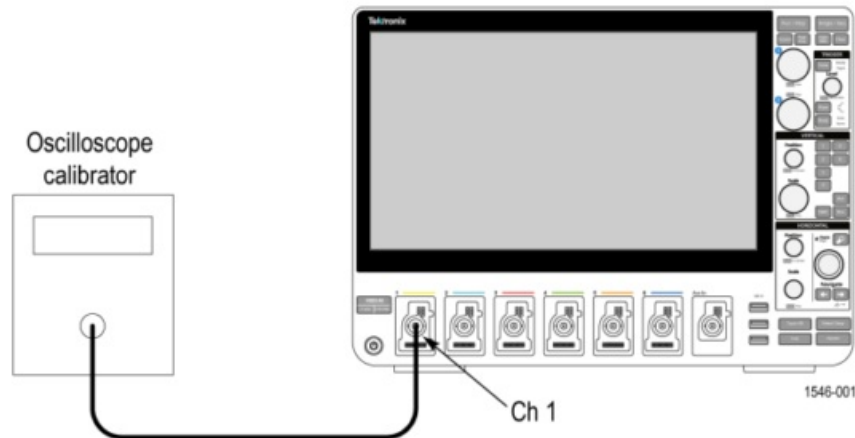
Check input impedance

This test checks the input impedance on all channels.

1. Connect the output of the oscilloscope calibrator (for example, Fluke 9500) to the oscilloscope channel 1 input, as shown in the following illustration.

⚠WARNING: Be sure to set the generator to Off or 0 volts before connecting, disconnecting, and/or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.

⚠Note: Impedance measuring equipment that produces a voltage across the channel that exceeds the measurement range of the instrument may report erroneous impedance results. A measurement voltage exceeds the measurement range of the instrument when the resulting trace is not visible on the graticule.

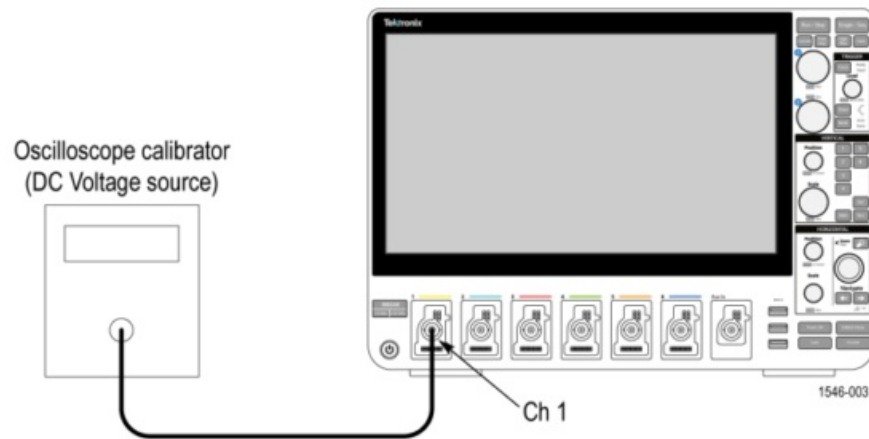


2. Set the calibrator to measure 1 M Ω impedance.
3. Tap File > Default Setup.
4. Test 1 M Ω input impedance.
 - a. Tap the channel 1 button on the Settings bar.
 - b. Double tap the Ch 1 badge to open its menu.
 - c. Set Termination to 1 M Ω .
 - d. Set the Vertical Scale to the value to test in the test record (first value is 10 mV/div).
5. Use the calibrator to measure the input impedance of the oscilloscope and enter the value in the test record.
6. Repeat steps 4.d on page 119 and 5 on page 119 for all vertical scale settings in the test record for the channel.
7. Test 50 Ω input impedance as follows:
 - a. Set the calibrator impedance to measure 50 Ω impedance.
 - b. Double-tap the Ch 1 badge and set Termination to 50 Ω .
 - c. Repeat steps 4.d on page 119 through 6 on page 119 for all vertical scale settings in the test record for the channel.
8. Repeat the procedures for all remaining channels.
 - a. Turn the calibrator output Off.
 - b. Move the calibrator connection to the next channel to test.
 - c. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
 - d. Tap the channel button on the Settings bar of the next channel to test.
 - e. Starting from step 2 on page 119, repeat the procedures until all channels have been tested.

Check DC gain accuracy

This test checks the DC gain accuracy.

1. Connect the oscilloscope to a calibrated DC voltage source. If you are using the Fluke 9500 calibrator, connect the calibrator head to the oscilloscope channel to **test**.



WARNING: Set the generator output to Off or 0 volts before connecting, disconnecting, and/or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.

2. Tap File > Default Setup.
3. Double-tap the Acquisition badge and set Acquisition Mode to Average.
4. Set the Number of Waveforms to 16.
5. Tap outside the menu to close the menu.
6. Double-tap the Trigger badge and set the trigger Source to AC line.
7. Tap outside the menu to close it.
8. Add the Mean measurement to the Results bar:
 - a. Tap the Add New... Measure button to open the Add Measurements menu.
 - b. Set the Source to Ch 1.
 - c. In the Amplitude Measurements panel, double-tap the Mean button to add the Mean measurement badge to the Results bar.
9. Tap outside the menu to close it.
10. Double-tap the Mean results badge.
11. Tap Show Statistics in Badge.
12. Tap FILTER/LIMIT RESULTS to open the panel.
13. Tap Limit Measurement Population to toggle it to On.
14. Tap outside the menu to close it.
15. Tap the channel button of the channel to test, to add the channel badge to the Settings bar.
16. Double tap the channel to test badge to open its menu and set the channel settings:
 - a. Set Vertical Scale to 1 mV/div.
 - b. Set Termination to 50 Ω .
 - c. Tap Bandwidth Limit and set to 20 MHz.
 - d. Tap outside the menu to close it.
17. Record the negative-measured and positive-measured mean readings in the Expected gain worksheet as follows:
 - a. On the calibrator, set the DC Voltage Source to the Vvalue as listed in the 1 mV row of the worksheet.
 - b. Double-tap the Acquisition badge and tap Clear to reset the measurement statistics.
 - c. Enter the Mean reading in the worksheet as V.
 - d. On the calibrator, set the DC Voltage Source to Vnegative negative-measured value as listed in the 1 mV row of the worksheet.
 - e. Double-tap the Acquisition badge (if not open) and tap Clear.
 - f. Enter the Mean reading in the worksheet as Vpositivepositive-measured.

Table 1: Expected gain worksheet

Oscilloscope vertical scale setting	V diffExpected	Vnegative	Vpositive	Vnegative-measured	Vpositive-measured	Vdiff	Test result (Gain accuracy)
1 mV/div	7 mV	-3.5 mV	+3.5 mV				
2 mV/div	14 mV	-7 mV	+7 mV				
5 mV/div	35 mV	-17.5 mV	+17.5 mV				
10 mV/div	70 mV	-35 mV	+35 mV				
20 mV/div	140 mV	-70 mV	+70 mV				
50 mV/div	350 mV	-175 mV	+175 mV				
100 mV/div	700 mV	-350 mV	+350 mV				
200 mV/div	1400 mV	-700 mV	+700 mV				
500 mV/div	3500 mV	-1750 mV	+1750 mV				
1.0 V/div	7000 mV	-3500 mV	+3500 mV				
20 mV/div at 250 MHz	140 mV	-70 mV	+70 mV				
20 mV/div at Full BW	140 mV	-70 mV	+ 70 mV				

18. Calculate Gain Accuracy as follows:

a. Calculate V_{as} as follows:

$$V_{diff} = |V_{diffnegative-measured} - V|$$

b. Enter V_{in} in the worksheet.

c. Calculate Gain Accuracy as follows: $\text{diffGain Accuracy} = ((V_{diff} - V_{positive-measured} \text{diffExpected}) / V_{diffExpected}) \times 100\%$

d. Enter the Gain Accuracy value in the worksheet and in the test record.

19. Repeat steps 16 on page 120 through 18 on page 121 for all vertical scale settings in the work sheet and the test record.

20. Repeat tests at 1 M Ω impedance as follows:

a. Set the calibrator to 0 volts and 1 M Ω output impedance.

b. Double-tap the badge of the channel being tested.

c. Set the Termination to 1 M Ω

d. Repeat steps 16 on page 120 through 19 on page 121 for all vertical scale settings in the test record.

21. Repeat the procedure for all remaining channels:

a. Set the calibrator to 0 volts and 50 Ω output impedance.

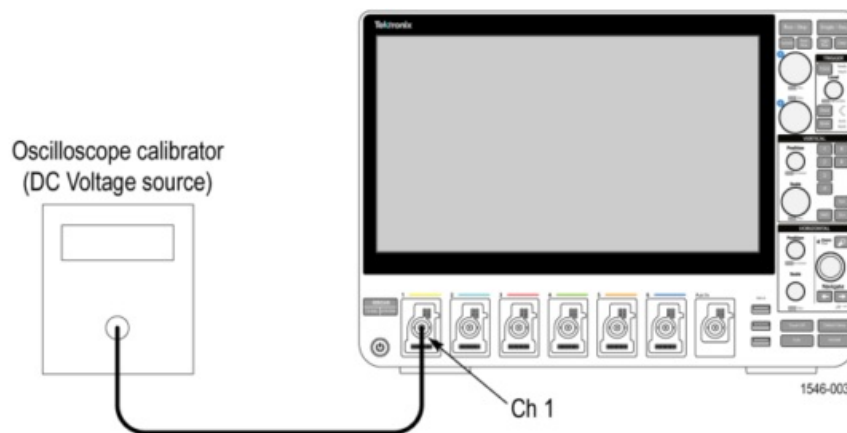
b. Move the calibrator output to the next channel input to be tested.

- c. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
 - d. Double-tap the Mean measurement badge.
 - e. Tap the Configure panel.
 - f. Tap the Source 1 field and select the next channel to test.
 - g. Starting from step 16 on page 120, set the values from the test record for the channel under test, and repeat the above steps until all channels have been tested.
22. Touch outside a menu to close the menu.

Check DC offset accuracy

This test checks the offset accuracy at 50 Ω and 1 M Ω input impedance.

1. Connect the oscilloscope to a calibrated DC voltage source. If you are using the Fluke 9500B calibrator as the DC voltage source, connect the calibrator head to the oscilloscope channel 1.



⚠ WARNING: Set the generator output to Off or 0 volts before connecting, disconnecting, or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.

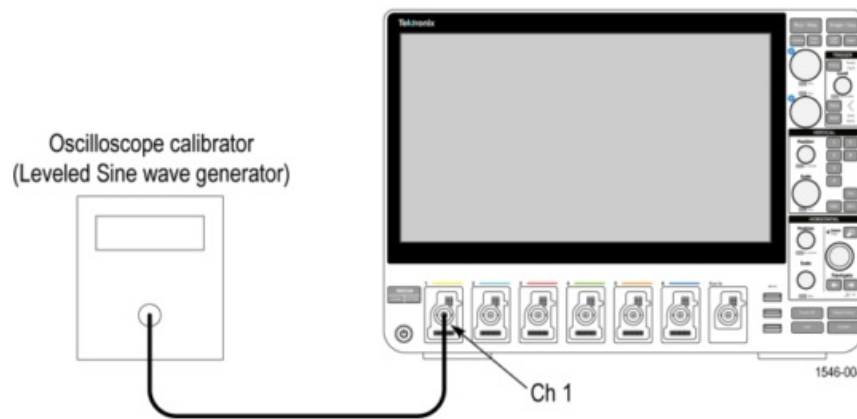
2. Tap File > Default Setup.
3. Double-tap the Acquisition badge and set Acquisition Mode to Average.
4. Set the Number of Waveforms to 16.
5. Tap outside the menu to close the menu.
6. Double-tap the Trigger badge and set the trigger Source to AC line.
7. Add the Mean measurement to the Results bar:
 - a. Tap the Add New... Measure button to open the Add Measurements menu.
 - b. Set the Source to Ch 1.
 - c. In the Amplitude Measurements panel, double-tap the Mean button to add the Mean measurement badge to the Results bar.
8. Tap outside the menu to close it.
9. Double-tap the Mean results badge.
10. Tap Show Statistics in Badge.
11. Tap FILTER/LIMIT RESULTS to open the panel.
12. Tap Limit Measurement Population to toggle it to On.
13. Tap outside the menu to close it.
14. Tap the channel button on the Settings bar to add the channel under test to the Settings bar.
15. Double-tap the channel under test badge to open its configuration menu and change the vertical settings:

- a. Set Vertical Scale to 1 mV/div.
 - b. Set Offset to 900 mV.
 - c. Set Position to 0 by tapping Set to 0.
 - d. Set Termination to 50 Ω .
 - e. Tap Bandwidth Limit and set to 20 MHz.
 - f. Tap outside the menu to close it.
16. Set the calibrator output to +900 mV, as shown in the test record, and turn the calibrator output On.
 17. Enter the Mean measurement value in the test record.
 18. Double-tap the channel under test badge to open its configuration menu and change the Offset to -900 mV.
 19. Set the calibrator output to -900 mV, as shown in the test record.
 20. Enter the Mean measurement value in the test record.
 21. Repeat step 15 on page 122 through 20 on page 123, changing the channel vertical settings and the calibrator output as listed in the test record for the channel under test.
 22. Repeat the channel tests at 1 M Ω impedance.
 - a. Set the calibrator output to Off or 0 volts.
 - b. Change the calibrator impedance to 1 M Ω and voltage to +900 mV.
 - c. Turn the calibrator output On.
 - d. Repeat steps 15 on page 122 through 20 on page 123, changing the channel Termination to 1 M Ω and the vertical Offset value and the calibrator output as listed in the 1 M Ω test record for the channel under test.
 23. Repeat the procedure for all remaining channels.
 - a. Double-tap the Mean measurement badge.
 - b. Tap the Configure panel.
 - c. Tap the Source 1 field and select the next channel to test.
 - d. Set the calibrator to 0 volts and 50 Ω output impedance.
 - e. Move the calibrator output to the next channel input to test.
 - f. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
 - g. Tap the channel button on the oscilloscope Settings bar of the next channel to test.
 - h. Starting from step 2 on page 122 , repeat the procedure until all channels have been tested.

Check analog bandwidth

This test checks the bandwidth at 50 Ω and 1 M Ω terminations for each channel. The typical bandwidth at 1 M Ω termination is checked on the products as a functional check.

1. Connect the output of the calibrated leveled sine wave generator to the oscilloscope channel 1 input as shown in the following **illustration**.



⚠WARNING: Set the generator to off or 0 volts before connecting, disconnecting, and/or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.

2. Tap File > Default Setup to reset the instrument and add the channel 1 badge and signal to the display.
3. Add the peak-to-peak measurement.
 - a. Tap the Add New. Measure button.
 - b. Set the Source to the channel under test.
 - c. In the Amplitude Measurements panel, double-tap the Peak-to-Peak measurement button to add the measurement badge to the Results bar.
 - d. Tap outside the menu to close it.
 - e. Double-tap the Peak-to-Peak results badge.
 - f. Tap Show Statistics in Badge.
 - g. Tap FILTER/LIMIT RESULTS to open the panel.
 - h. Tap Limit Measurement Population to toggle it to On.
 - i. Tap outside the menu to close it.
4. Set the channel under test settings:
 - a. Double-tap the badge of the channel under test to open its configuration menu.
 - b. Set Vertical Scale to 1 mV/div.
 - c. Set Termination to 50 Ω .
 - d. Tap outside the menu to close it.
5. Adjust the leveled sine wave signal source to display a waveform of 8 vertical divisions at the selected vertical scale with a set frequency of 10 MHz. For example, at 5 mV/div, use a ≥ 40 mVp-p signal; at 2 mV/div, use a ≥ 16 mV signal.

⚠Note: At some V/div settings, the generator may not provide 8 vertical divisions of signal. Set the generator output to obtain as many vertical divisions of signal as possible.

6. Double-tap the Horizontal badge in the Settings bar.
7. Set the Horizontal Scale to 1 ms/division.
8. Tap outside the menu to close it.
9. Record the Peak-to-Peak measurement in the V entry of the test record.
10. Double-tap the Horizontal badge in the Settings bar. in-pp
11. Set the Horizontal Scale to 4 ns/division .
12. Adjust the signal source to the maximum bandwidth frequency for the bandwidth and model being tested.
13. Record the peak-to-peak measurement.
 - a. Record the Peak-to-Peak measurement at the new frequency in the Vbw-ppp-pentry of the test record.
14. Use the values of V bw-pp and V in-pp recorded in the test record, and the following equation, to calculate the

Gain at bandwidth: $\text{Gain} = V_{bw-pp} / V_{in-pp}$.

To pass the performance measurement test, Gain should be ≥ 0.707 . Enter Gain in the test record.

15. Repeat steps 4 on page 124 through 14 on page 124 for all combinations of Vertical Scale settings listed in the test record.
16. Repeat the tests at 1 M Ω impedance.
 - a. Set the calibrator output to Off or 0 volts.
 - b. Change the calibrator impedance to 1 M Ω .
 - c. Double-tap the badge of the channel under test to open its menu.
 - d. Set the Termination to 1 M Ω .
 - e. Repeat steps 4 on page 124 through 16 on page 124 , but leave the termination set to 1 M Ω .
17. Repeat the test for all remaining channels.
 - a. Set the calibrator to 0 volts and 50 Ω output impedance.
 - b. Move the calibrator output to the next channel input to be tested.
 - c. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
 - d. Tap the channel button on the oscilloscope Settings bar of the next channel to test.
 - e. Double-tap the Peak-to-Peak measurement badge.
 - f. Tap the Configure panel.
 - g. Tap the Source 1 field and select the next channel to test.
 - h. Starting from step 4 on page 124, repeat the procedure until all channels have been tested.

Check random noise

This test checks random noise at 1 M Ω and 50 Ω for each channel, in HiRes acquisition mode. You do not need to connect any test equipment to the oscilloscope for this test.

1. Disconnect everything from the oscilloscope inputs.
2. Tap File > Default Setup.
3. Turn on HiRes Mode except for 1.5`GHz instruments. 1.5`GHz instruments must be tested in Sample mode.
4. Add the AC RMS measurement:
 - a. Tap the Add New... Measure button.
 - b. Set the Source to the channel being tested.
 - c. In the Amplitude Measurements panel, double-tap the AC RMS measurement button to add the measurement badge to the Results bar.
 - d. Tap outside the menu to close it.
 - e. Double-tap the AC RMS measurement badge and tap Show Statistics in Badge to display statistics in the measurement badge.
 - f. Tap the Filter / Limit Results panel.
 - g. Turn on Limit Measurement Population.
 - h. Set the limit to 100.
 - i. Tap outside the menu to close it.
5. Set up the Horizontal mode:
 - a. Double-tap the Horizontal setting badge.
 - b. Set Horizontal Mode to Manual.
 - c. Set the Sample Rate to 6.25 GS/s.
 - d. Set the Record Length to 2 Mpts.

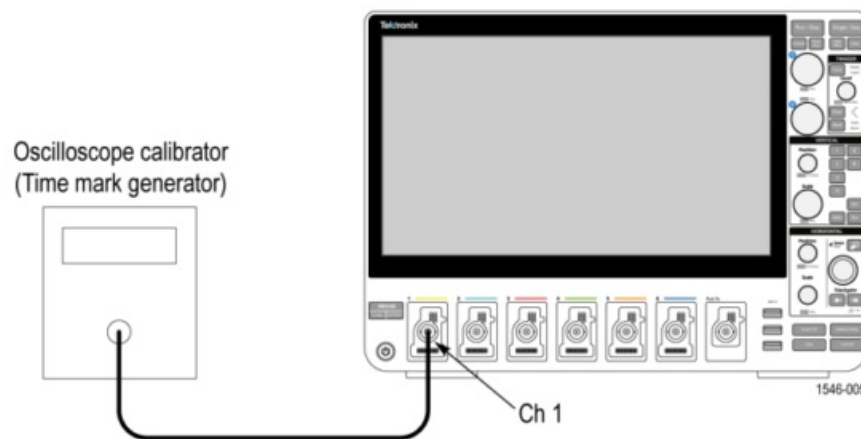
- e. Tap outside the menu to close it.
6. Double-tap the Channel badge of the channel being tested.
7. Set the Vertical Scale value to 1 mV.
8. Check 1 M Ω termination.
 - a. In the Channel badge menu, tap 1 M Ω termination.
 - b. Tap the Bandwidth Limit field and select the highest frequency listed.
 - c. Set the channel Position value to 340 mdivs.
 - d. Once the measurement count (N) in the AC RMS measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
 - e. Set the channel vertical Position value to 360 mdivs.
 - f. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
 - g. Average the two values and record the result in the 1 mV/div > Full row of the 1 M Ω column of the Test Result record.
 - h. In the channel badge menu, tap the Bandwidth Limit field and select 250 MHz.
 - i. Set the channel vertical Position value to 340 mdivs.
 - j. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
 - k. Set the channel vertical Position value to 360 mdivs.
 - l. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
 - m. Average the two values and record the result in the 1 mV/div > 250MHz limit row of the 1 M Ω column of the Test Result record.
 - n. Tap the Bandwidth Limit field and select 20 MHz.
 - o. Set the channel vertical Position value to 340 mdivs.
 - p. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
 - q. Set the channel vertical Position value to 360 mdivs.
 - r. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
 - s. Average the two values and record the result in the 1 mV/div > 20MHz limit row of the 1 M Ω column of the Test Result record.
9. Check 50 Ω termination.
 - a. In the Channel badge, set Termination to 50 Ω .
 - b. Tap the Bandwidth Limit field and select the highest frequency listed.
 - c. Set the channel vertical Position value to 340 mdivs.
 - d. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
 - e. Set the channel vertical Position value to 360 mdivs.
 - f. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
 - g. Average the two values and record the result in the 1 mV/div > Full row of the 50 Ω column of the Test Result record.
 - h. Tap the Bandwidth Limit field and select 250 MHz.

- i. Set the channel vertical Position value to 340 mdivs.
 - j. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
 - k. Set the channel vertical Position value to 360 mdivs.
 - l. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
 - m. Average the two values and record the result in the 1 mV/div > 250MHz limit row of the 50 Ω column of the Test Result record.
 - n. Tap the Bandwidth Limit field and select 20 MHz.
 - o. Set the channel vertical Position value to 340 mdivs.
 - p. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
 - q. Set the channel vertical Position value to 360 mdivs.
 - r. Once the measurement count (N) in the measurement badge reaches 100, record the AC RMS Mean value (the μ readout).
 - s. Average the two values and record the result in the 1 mV/div > 20MHz limit row of the 50 Ω column of the Test Result record.
10. Repeat 1 M Ω and 50 Ω tests at all V/div settings for the current channel.
 - a. In the Channel badge, set the Vertical Scale setting to the next value in the test record (2 mV, 5 mV, and so on, up to 1 V/div).
 - b. Repeat steps 8 on page 125 through 9 on page 126.
 11. Repeat all tests for the remaining input channels.
 - a. Double-tap the AC RMS measurement badge.
 - b. Tap the Configure panel.
 - c. Tap the Source 1 field and select the next channel to test.
 - d. Double-tap the channel badge of the channel that you have finished testing and set Display to Off.
 - e. Tap the channel button on the oscilloscope Settings bar of the next channel to test.
 - f. Double-tap the channel badge for the channel being tested.
 - g. Starting at step 7 on page 125, repeat these procedures for each input channel.

Check long term sample rate

This test checks the sample rate and delay time accuracy (time base).

1. Connect the output of a time mark generator to the oscilloscope channel 1 input using a 50 Ω cable, as shown in the following **illustration**.



⚠WARNING: Set the generator output to off or 0 volts before connecting, disconnecting, and/or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.

2. Set the time mark generator period to 80 ms. Use a time mark waveform with a fast rising edge.
3. If it is adjustable, set the time mark amplitude to approximately 2 V.
4. Tap File > Default Setup.P-P
5. Tap the channel 1 button on the Settings bar.
6. Double-tap the Channel 1 badge to open its Configuration menu.
7. Set Termination to 50 Ω .
8. Set Vertical Scale to 500 mV.
9. Set the Position value to center the time mark signal on the screen.
10. Tap outside the menu area to close it.
11. Double-tap the Horizontal settings badge.
12. Set the Horizontal Scale to 100 ns/div.
13. Tap outside the menu area to close it.
14. Double-tap the Trigger settings badge.
15. Set Source to the channel being tested.
16. Set the Level as necessary for a triggered display.
17. Tap outside the menu area to close it.
18. Double-tap the Horizontal settings badge.
19. Adjust the Position value to move the trigger point to the center of the screen.
20. Turn Delay to On and set Position to 80 ms.
21. Set the Horizontal Scale to 100 ns/div.
22. Observe where the rising edge of the marker crosses the center horizontal graticule line. The rising edge should cross within ± 2 divisions of the vertical center graticule. Enter the deviation in the test record.

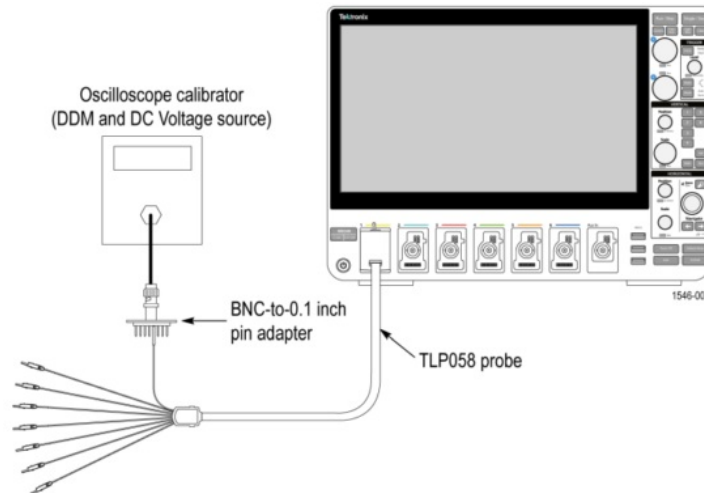
⚠Note: A 2.5×10^{-6} time base error is 2 divisions of displacement.

Check digital threshold accuracy

This test checks the threshold accuracy of the TLP058 logic probe digital channels D0-D7 at 0 V and 25 °C, for all oscilloscope input channels.

⚠Note: Threshold Accuracy is a function of the logic probe only. It is a typical specification. The Threshold Accuracy test checks the typical logic probe performance, and may be considered a functional check of the oscilloscope digital input.

1. Connect a TLP058 digital probe to channel 1.



2. Connect the DC voltage source to digital channel D0.

⚠WARNING: Set the generator output to Off or 0 volts before connecting, disconnecting, or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.

If you are using the Fluke 9500 calibrator as the DC voltage source, connect the calibrator head to the digital channel D0, using the BNC-to-0.1 inch pin adapter listed in the Required equipment table. Be sure to connect channel D0 to both the corresponding signal pin and to a ground pin on the adapter.

3. Tap File > Default Setup. This resets the instrument and adds the channel 1 badge and signal to the display.
4. Display the digital channels and set the thresholds.
 - a. Double-tap the badge of the channel under test on the Settings bar.
 - b. Double-tap the Threshold field at the bottom of the menu and set the value to 0 V.
 - c. Tap Set All Thresholds. All thresholds are now set for the 0 V threshold check.
 - d. Tap outside the menu to close it.
5. Double-tap the Horizontal badge in the Settings bar.
6. Set the Horizontal Scale to 10 ns/div.
7. Tap outside the menu to close it.
8. Set the calibrator DC voltage output (Vs) to -400 mV.
9. Wait 1 second. Verify that the logic level is low on D0.
10. Increment Vs by +10 mV. Wait 1 second and check the logic level of the channel D0 signal display.

If the signal level is a logic low or is alternating between high and low, continue to increment Vs by +10 mV, wait 1 second, and check the logic level until the logic state is a steady high.
11. Record this Vs value as Vs- for D0 of the test record.
12. Double-tap the Trigger badge and set the Slope to Falling edge.
13. Set the DC voltage source (Vs) to +400 mV.
14. Wait 1 second. Verify that the logic level is high.
15. Decrement Vs by -10 mV. Wait 1 second and check the logic level of the channel D0 signal display.

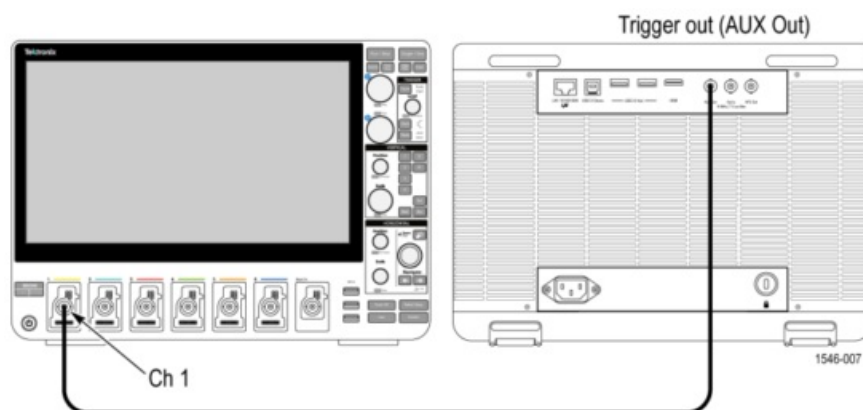
If the signal level is a logic high or is alternating between high and low, continue to decrement Vs by -10 mV, wait 1 second, and check the logic level until the logic state is a steady low.
16. Record this Vs value as Vs+ for D0 of the test record.
17. Find the average using this formula: $Vs_{Avg} = (Vs- + Vs+)/2$.
18. Record the average as the test result for D0 in the test record. The test result should be between the low and high limits.
19. Repeat the procedure for all remaining digital channels.

- a. Connect the next digital channel to be tested (D1, D2, and so on) to the DC voltage source.
 - b. Repeat steps 8 on page 128 through 19 on page 129, until all digital channels have been tested for this input channel.
20. Repeat the procedure for all remaining input channels.
- a. Move the TLP058 digital probe from channel 1 to channel 2.
 - b. Set the generator output to 0 volts and Off.
 - c. Repeat steps starting at 2 on page 128 for the channel being tested (channel 2, channel 3, and so on).

Check AUX Out output voltage levels

This test checks the output voltage levels from the AUX Out connector.

1. Use a 50 Ω cable to connect the AUX Out signal from the rear of the instrument to the channel 1 input of the same instrument, as shown in the following illustration.



2. Tap File > Default Setup. This resets the instrument and adds the channel 1 badge and signal to the display.
3. Double-tap the badge of the channel 1 badge to open its configuration menu.
4. Set the Vertical Scale to 1 V/div.
5. Tap outside the menu to close it.
6. Double-tap the Horizontal badge in the Settings bar.
7. Set the Horizontal Scale to 400 ns/div.
8. Tap outside the menu to close it.
9. Record the Maximum and Minimum measurements at 1 M Ω termination.
 - a. Tap the Add New... Measure button.
 - b. In the Amplitude Measurements panel, set the Source to Ch 1.
 - c. Double-tap the Maximum button to add the measurement badge to the Results bar.
 - d. Double-tap the Minimum button to add the measurement badge to the Results bar.
 - e. Tap outside the menu to close it.
 - f. Double-tap the Maximum results badge.
 - g. Tap Show Statistics in Badge.
 - h. Tap FILTER/LIMIT RESULTS to open the panel.
 - i. Tap Limit Measurement Population to toggle it to On.
 - j. Tap outside the menu to close it.
 - k. Double-tap the Minimum results badge.
 - l. Tap Show Statistics in Badge.
 - m. Tap FILTER/LIMIT RESULTS to open the panel.
 - n. Tap Limit Measurement Population to toggle it to On.

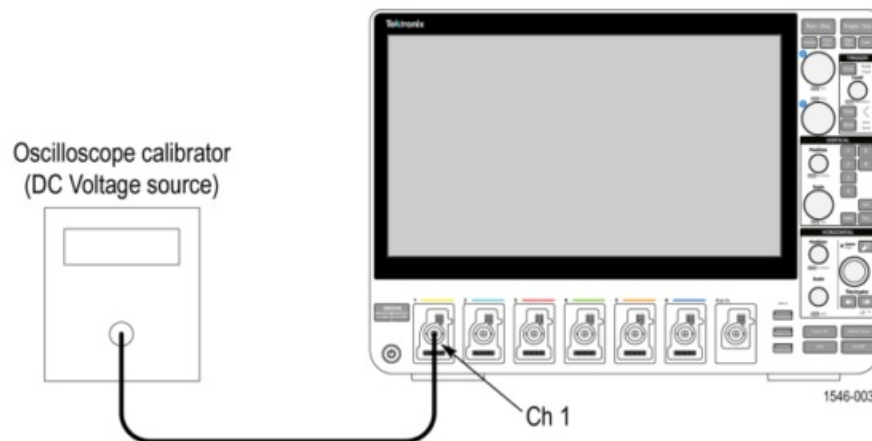
- o. Tap outside the menu to close it.
 - p. Enter the Maximum and Minimum measurement readings in the 1 M Ω row of the test record.
10. Record the Maximum and Minimum measurements at 50 Ω termination.
- a. Double-tap the Ch 1 badge to open its configuration menu.
 - b. Set Termination to 50 Ω .
 - c. Tap outside the menu to close it.
 - d. Enter the Maximum and Minimum measurement readings in the 50 Ω row of the test record.

Check DVM voltage accuracy (DC)

This test checks the DC voltage accuracy of the Digital Volt Meter (DVM) option. The DVM option is available for free when you register the instrument at tek.com.

Procedure

1. Connect the oscilloscope to a DC voltage source to run this test. If using the Fluke 9500 calibrator as the DC voltage source, connect the calibrator head to the oscilloscope channel to **test**.



⚠ WARNING: Set the generator output to Off or 0 volts before connecting, disconnecting, or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.

2. Set the calibrator impedance to 1 M Ω .
3. Tap File > Default Setup. This resets the instrument and adds the channel 1 badge and signal to the display.
4. Set the channel settings.
 - a) Double tap the badge of the channel under test to open its menu.
 - b) Check that Position is set to 0 divs. If not, set the position to 0 divisions.
 - c) Confirm that Termination is set to 1 M Ω .
 - d) Set the Bandwidth Limit to 20 MHz.
5. Set the calibrator impedance to 1 M Ω .
6. Double-tap the Horizontal badge and set Horizontal Scale to 1 ms/div.
7. Tap outside the menu to close it.
8. Double-tap the Acquisition badge and set the Acquisition Mode to Average.
9. Verify or set the Number of Waveforms to 16.
10. Tap outside the menu to close it.
11. Double-tap the Trigger badge and set the Source to AC Line.
12. Tap outside the menu to close it.
13. Tap the DVM button to add the DVM badge to the Results bar.

14. In the DVM menu, set Source to the channel to be tested.
15. Set Mode to DC.
16. Tap outside the menu to close it.
17. Set the calibrator to the input voltage shown in the test record (for example, –5 V for a 1V/div setting).
18. In the channel under test menu, set the Offset value to that shown in the test record (for example, –5 V for –5 V input and 1 V/div setting).
19. Set the Vertical Scale field to match the value in the test record (for example, 1 V/div).
20. Enter the measured value on the DVM badge into the DVM Voltage Accuracy Tests record.
21. Repeat the procedure (steps 17 on page 131, 18 on page 131, 19 on page 131 and 20 on page 131) for each volts/division setting shown in the test record.
22. Repeat all steps, starting with step 4 on page 131, for each oscilloscope channel to check. To set the next channel to test:
 - a) Double tap the badge of the channel under test to open its menu.
 - b) Set Display to Off.
 - c) Tap the channel button in the Settings bar of the next channel to test to add that channel badge and signal to the display.

Check DVM voltage accuracy (AC)

This test checks the AC voltage accuracy of the Digital Volt Meter (DVM) option. The DVM option is available for free when you register the instrument at tek.com.

Procedure

1. Connect the output of the leveled square wave generator (for example, Fluke 9500) to the oscilloscope channel 1 input.

⚠WARNING: Set the generator output to Off or 0 volts before connecting, disconnecting, or moving the test hookup during the performance of this procedure. The generator is capable of providing dangerous voltages.
2. Set the generator to 50 Ω output impedance (50 Ω source impedance).
3. Set the generator to produce a square wave of the amplitude and frequency listed in the test record (for example, 20 mV at 1 kHz).
4. Tap File > Default Setup to reset the instrument and add the channel 1 badge and signal to the display.
5. Tap the DVM button to add the DVM badge to the Results bar.
6. Set the DVM Mode to AC RMS.pp
7. In the DVM menu, set Source to the channel to be tested.
8. Double-tap the channel badge of the channel being tested to open its configuration menu.
9. Set Termination to 50 Ω .
10. Use the Vertical Scale controls to set the signal height so that the signal covers between 4 and 8 vertical divisions on the screen.
11. Enter the DVM measured value in the test record.
12. Repeat steps 10 on page 132 and 11 on page 132 for each voltage and frequency combination shown in the record.
13. Repeat all steps to test all remaining oscilloscope channels. To set the next channel to test:
 - a) Double tap the badge of the channel under test to open its menu.

b) Set Display to Off.

c) Tap the channel button in the Settings bar of the next channel to test to add that channel badge and signal to the display.

Check trigger frequency accuracy and maximum input frequency

This test checks trigger frequency counter accuracy. The trigger frequency counter is part of the free DVM and trigger frequency option that is available when you register the instrument at tek.com.

Procedure

1. Tap File > Default Setup to reset the instrument and add the channel 1 badge and signal to the display.
2. Connect the 10 MHz Reference out from the time mark generator to the Ref In connector on the back of the oscilloscope.
3. Connect the output of the time mark generator to the oscilloscope channel input being tested using a 50 Ω cable.
Set the time mark generator to a 50 Ω source and a fast rising edge waveform (≥ 3 mV/ns).
4. Set the time mark generator frequency to the first value shown in the test record, starting at 100 Hz.
5. Set the mark amplitude to 1 V, which makes a 2 divisions high waveform.
6. Double-tap the channel badge being tested (starting with channel 1) and set Termination to 50 Ω .pp
7. Set the channel Vertical Scale to 500 mV/div.
8. Tap outside the menu to close it.
9. Double-tap the Acquisition badge and set the Timebase Reference Source to External (10 MHz) .
10. Tap outside the menu to close it.
11. Double-tap the Horizontal badge and use the Horizontal Scale controls to display at least 2 cycles of the waveform.
12. Tap outside the menu to close it.
13. Double-tap the Trigger badge to open its menu.
 - a) Set the Source field to the input channel being tested.
 - b) Tap the Set to 50% button to obtain a stable display.
 - c) Tap the Mode & Holdoff panel to open the Mode & Holdoff configuration menu.
 - d) In the Mode & Hold Off menu, set the Trigger Frequency Counter to On. The trigger frequency readout is at the bottom of the Trigger badge.
 - e) Tap outside the menu to close it.
14. Double-tap the channel badge being tested (starting with channel 1) and use the Position controls to vertically center the time mark in the waveform graticule.
15. Enter the value of the trigger frequency (F readout in the Trigger badge) in the test record for that frequency.
16. Repeat this procedure for each frequency setting shown in the record. Make sure to adjust the Horizontal scale after each calibrator frequency change to show at least two cycles of the waveform on the screen.
17. Repeat all these steps to test each oscilloscope channel.

Check AFG sine and ramp frequency accuracy

This test verifies the frequency accuracy of the arbitrary function generator. All output frequencies are derived from a single internally generated frequency. Only one frequency point of channel 1 is required to be checked.

1. Connect a 50 Ω cable from the AFG Out connector to the frequency counter input as shown in the following

figure.

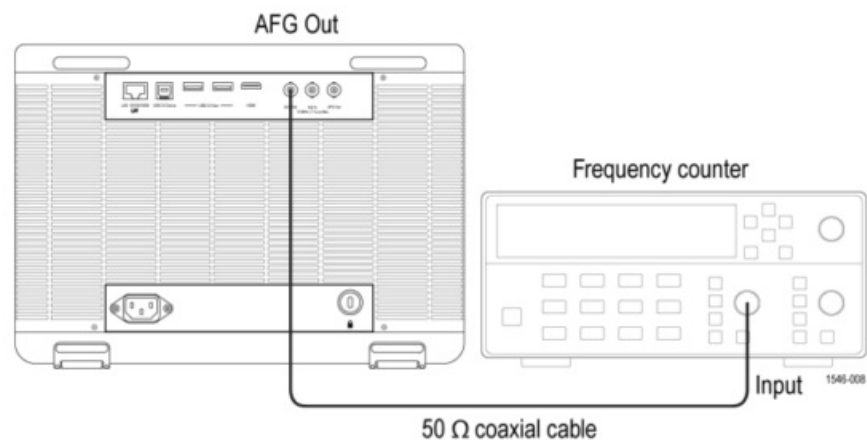


Figure 1: Frequency/period test

2. Tap File > Default Setup to set the instrument to the factory default settings.
3. Tap the AFG button to open the AFG menu.
4. Set the arbitrary function generator output as follows:

Select menu	Setting
Output	On
Waveform Type	Sine
Frequency	1.000000 MHz
Amplitude	1.00 V _{PP}

5. Turn on the frequency counter:
 - a. Double-tap the Trigger badge to open its menu.
 - b. Set the Source field to the input channel being tested.
 - c. Tap the Set to 50% button to obtain a stable display.
 - d. Tap the Mode & Holdoff panel to open the Mode & Holdoff configuration menu
 - e. In the Mode & Holdoff menu, set the Trigger Frequency Counter to On. The trigger frequency readout is at the bottom of the Trigger badge.
 - f. Tap outside the menu to close it.
6. Check that the reading of the frequency counter is between 0.999950 MHz and 1.000050 MHz. Enter the value in the Test record.

7. Set the arbitrary function generator output as follows:

Select menu	Setting
Waveform Type	Ramp
Frequency	500 kHz

8. Check that reading of the frequency counter is between **975 kHz** and **500.025 kHz**. Enter the value in the Test record.

Check AFG square and pulse frequency accuracy

This test verifies the frequency accuracy of the arbitrary function generator. All output frequencies are derived from a single internally generated frequency. Only one frequency point of channel 1 is required to be checked.

1. Connect the arbitrary function generator to the frequency counter as shown in the following figure.

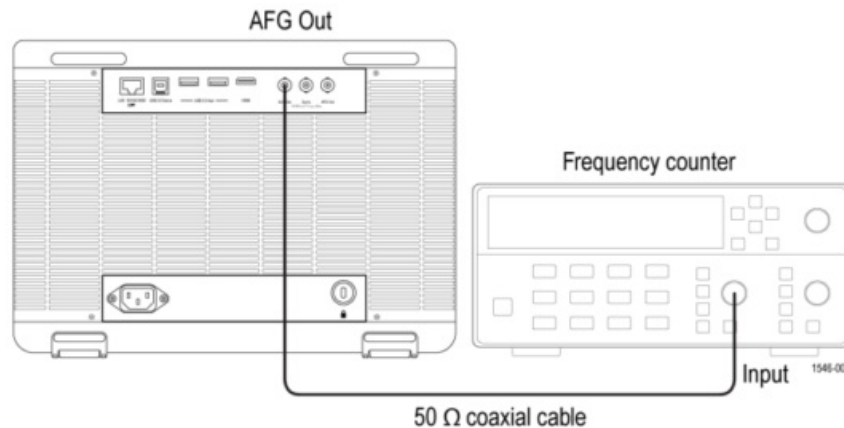


Figure 2: Frequency/period test

2. Tap File > Default Setup to set the instrument to the factory default settings.
3. Tap the AFG button to open the AFG menu.
4. Set the arbitrary function generator as follows:

Select menu	Setting
Waveform Type	Square
Frequency	1.000000 MHz
Amplitude	1.00 V _{PP}
Output	On

5. Turn on the frequency counter:
 - a. Double-tap the Trigger badge to open its menu.
 - b. Set the Source field to the input channel being tested.
 - c. Tap the Set to 50% button to obtain a stable display.
 - d. Tap the Mode & Holdoff panel to open the Mode & Holdoff configuration menu
 - e. In the Mode & Holdoff menu, set the Trigger Frequency Counter to On. The trigger frequency readout is at the bottom of the Trigger badge.
 - f. Tap outside the menu to close it.
6. Check that the frequency counter readout is between 0.999950 MHz and 1.00005 MHz. Enter the value in the Test record.
7. Set up the arbitrary function generator as follows:

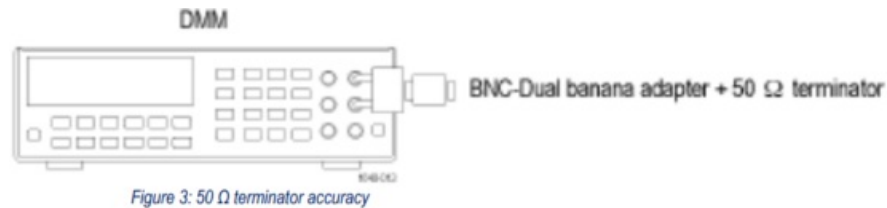
Select menu	Setting
Waveform Type	Pulse

8. Check that reading of the frequency counter is between 0.999950 MHz and 1.000050 MHz. Enter the value in the Test record.

Check AFG signal amplitude accuracy

This test verifies the amplitude accuracy of the arbitrary function generator. All output amplitudes are derived from a combination of attenuators and 3 dB variable gain. Some amplitude points are checked. This test uses a 50 Ω terminator. It is necessary to know the accuracy of the 50 Ω terminator in advance of this amplitude test. This accuracy is used as a calibration factor.

1. Connect the 50 Ω terminator to the DMM as shown in the following figure and measure the resistance value.



2. Calculate the 50 Ω calibration factor (CF) from the reading value and record as follows:

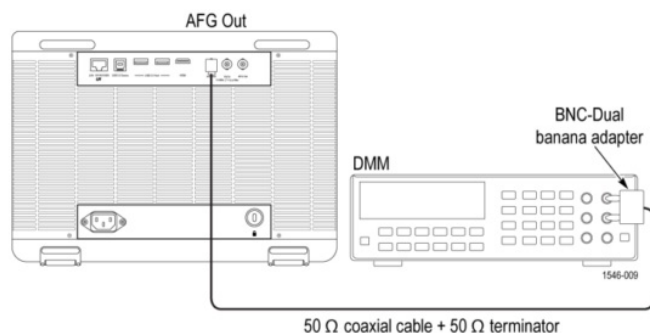
Table 2: CF (Calibration Factor) = $1.414 \times ((50 / \text{Measurement } \Omega) + 1)$

Measurement (reading of the DMM)	Calculated CF

Examples:

- For a measurement of 50.50 Ω , CF = $1.414 (50 / 50.50 + 1) = 2.814$.
- For a measurement of 49.62 Ω , CF = $1.414 (50 / 49.62 + 1) = 2.839$.

3. Connect the arbitrary function generator output to the DMM as shown in the following figure. Be sure to connect the 50 Ω terminator to the AFG Out connector.



4. Tap the AFG button and set up the arbitrary function generator output as follows:

Select menu	Setting
Waveform Type	Sine
Frequency	1.000000 kHz
Amplitude	30 mV _{PP}
Load Impedance	50 Ω
Output	On

5. Measure the AC RMS voltage readout on the DMM.
6. Multiply the DMM voltage by the calculated CF to get the corrected peak to peak voltage. Enter the resulting

value in the Measurement field in the following table.

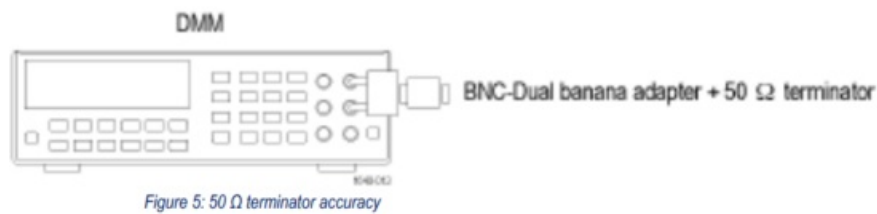
- Change the AFG output amplitude to the next value in the table.
- Repeat steps 5 on page 136 through 7 on page 136 for each amplitude value. Check that the peak to peak voltages are within the limits in the table below. Enter the values in the test record.

Waveform Type	Frequency	Amplitude	Measurement	Range
Sine	1.000 kHz	30.0 mV _{PP}		28.55 mV _{PP} – 31.45 mV _{PP}
Sine	1.000 kHz	300.0 mV _{PP}		294.5 mV _{PP} – 305.5 mV _{PP}
Sine	1.000 kHz	800.0 mV _{PP}		787.0 mV _{PP} – 813.0 mV _{PP}
Sine	1.000 kHz	1.500 V _{PP}		1.4765 V _{PP} – 1.523 5 V _{PP}
Sine	1.000 kHz	2.000 V _{PP}		1.969 V _{PP} – 2.031 V _{PP}
Sine	1.000 kHz	2.500 V _{PP}		2.4615 V _{PP} – 2.538 5 V _{PP}

Check AFG DC offset accuracy

This test verifies the DC offset accuracy of the arbitrary function generator. This test uses a 50 Ω terminator. It is necessary to know the accuracy of the 50 Ω terminator in advance of this test. This accuracy is used as a calibration factor.

- Connect the 50 Ω terminator to the DMM as shown in the following figure and measure the resistance value.



- Calculate the 50 Ω calibration factor (CF) from the reading value and record as follows:

Table 3: CF (Calibration Factor) = 0.5 × ((50 / Measurement Ω) + 1)

Measurement (reading of the DMM)	Calculated CF

Examples:

- For a measurement of 50.50 Ω, CF = 0.5 (50 / 50.50 + 1) = 0.9951.
- For a measurement of 49.62 Ω, CF = 0.5 (50 / 49.62 + 1) = 1.0038.

- Connect the arbitrary function generator output to the DMM as shown in the following figure. Be sure to connect the 50 Ω terminator to the arbitrary function generator AFG Output connector.

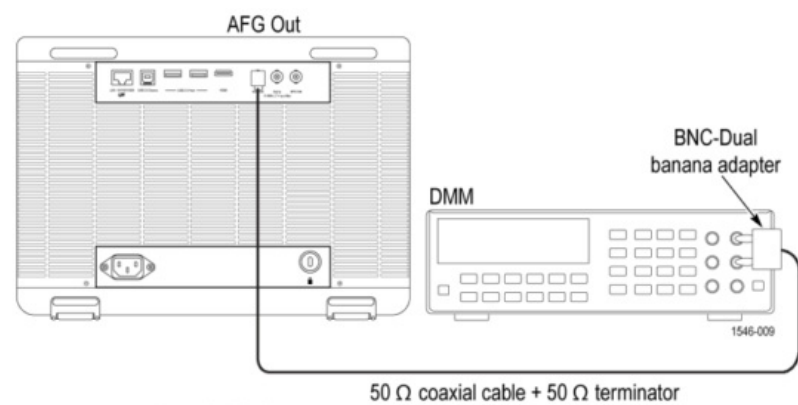


Figure 6: DC offset tests

- Tap the AFG button and set up the arbitrary function generator as follows:

Select menu	Setting
Waveform Type	DC
Offset	+ 1.25 V
Output	On

- Measure the voltage readout on the DMM.
- Multiply the DMM voltage by the calculated CF to get the corrected offset voltage. Enter the resulting value in the Measurement field in the following table.


Function	Offset	Measurement	Range
DC	+ 1.25 Vdc	Vdc	1.23025 Vdc to 1.26975 Vdc
DC	0.000 Vdc	Vdc	– 0.001 Vdc to + 0.001 Vdc
DC	– 1.25 Vdc	Vdc	-1.26975 Vdc to -1.23025 Vdc

- Change the AFG output amplitude to the next value in the table, measure the voltage readout on the DMM, multiply the DMM readout by the calculated CF to get the corrected offset voltage, and enter the resulting value in the Measurement field in the table.
- Verify that the corrected offset measurements are within the range.

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References

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